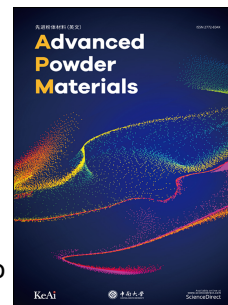


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Process–Structure–Property Relationships in Low-Temperature Microwave Dielectric Ceramics: From Glass-Assisted Sintering to Cold Sintering for 5G/6G Devices.

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Process–Structure–Property Relationships in Low-Temperature Microwave Dielectric Ceramics: From Glass-Assisted Sintering to Cold Sintering for 5G/6G Devices.

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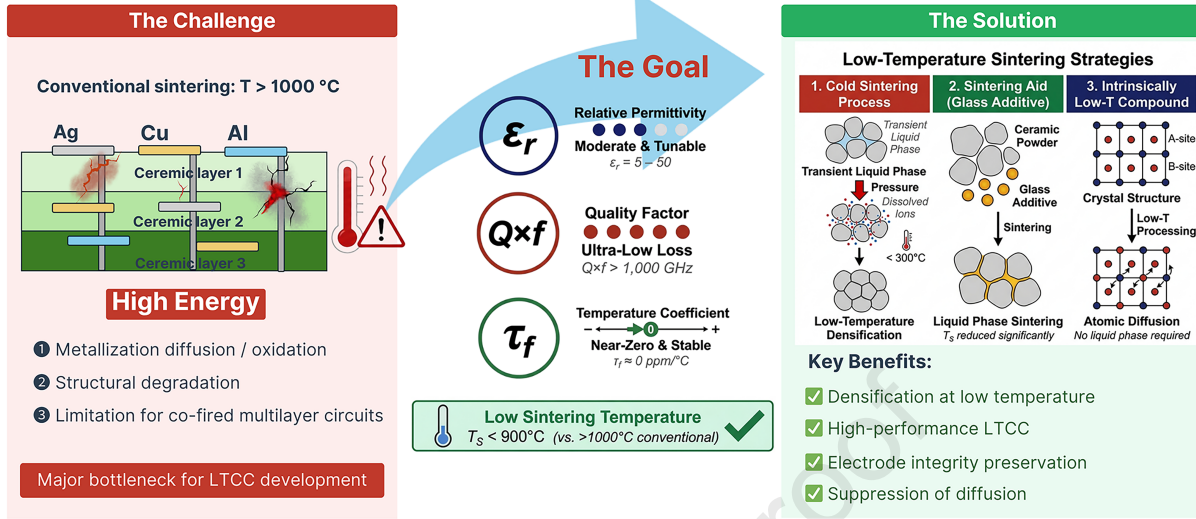
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Acknowledgments

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Process-Structure-Property Relationships in Low-Temperature Microwave Dielectric Ceramics



Emerging low-temperature sintering approaches for microwave dielectric ceramics were critically reviewed from a process-structure-properties perspective. Sintering additives, intrinsically low-temperature compounds, and cold sintering strategies enable reduced processing temperatures while preserving dielectric performance and LTCC compatibility.

1 **Process-Structure-Property Relationships in Low-Temperature** 2 **Microwave Dielectric Ceramics: From Glass-Assisted Sintering to** 3 **Cold Sintering for 5G/6G Devices.**

4 **Abstract:** With the rapid advancement of wireless communication from 5G to 6G, a pressing need
5 has emerged for microwave dielectric ceramics with excellent performance at reduced processing
6 temperatures, compatible with low-temperature Co-fired ceramic (LTCC) technology. This review
7 traces historical milestones and highlights modern design strategies for achieving optimum
8 dielectric constant, ultra-low dielectric loss, and near-zero temperature coefficient of resonant
9 frequency. Special emphasis is placed on recent advances in low-temperature densification routes,
10 including sintering aids, intrinsically low-sintering-temperature ceramic families, and novel
11 techniques like the cold sintering process (CSP). This review provides a critical analysis of the
12 performance trade-offs inherent to each strategy, addressing the persistent challenges in achieving
13 ultra-low loss. Furthermore, we highlight the paradigm shift toward a holistic, multifunctional
14 design imperative for 6G systems. Finally, the transformative potential of cross-disciplinary
15 approaches, particularly AI-assisted discovery and computational modeling, is discussed as a key
16 enabler for accelerating the design of next-generation, high-performance, and sustainable LTCC-
17 compatible materials.

18 **Keywords:** Microwave dielectric ceramic; Low-temperature co-fired ceramic (LTCC); Cold
19 sintering process (CSP); 5G/6G communication; Low dielectric loss; Sintering aid.

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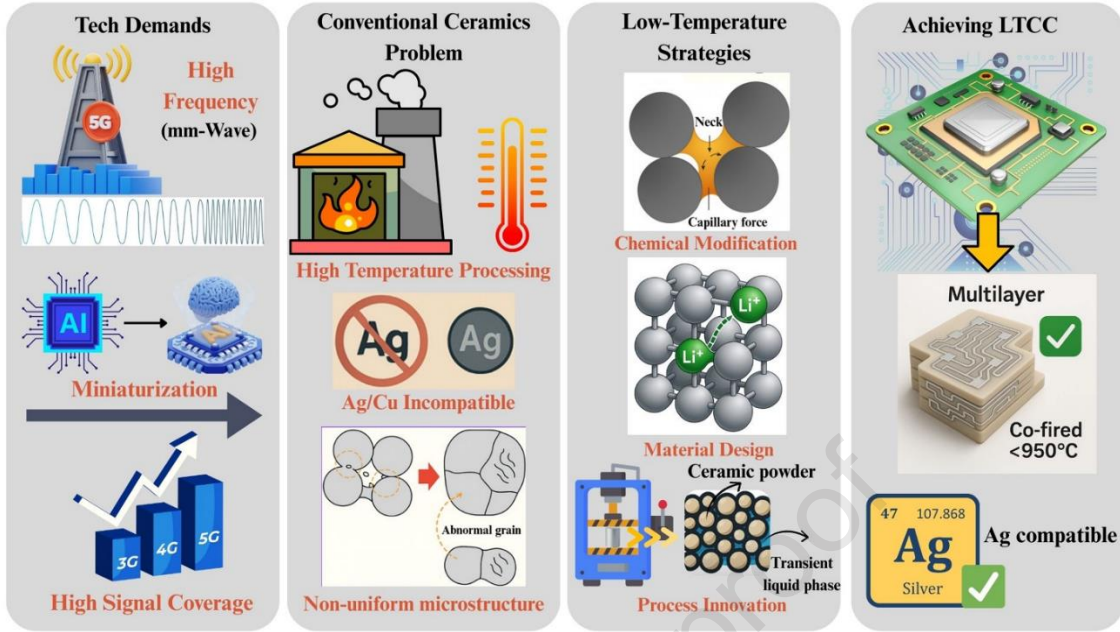
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23 1. Introduction

24 The ongoing evolution of wireless technology, from 4G to 5G and now towards 6G, is
25 driving increasingly strict demands for microwave component performance. To meet the needs of
26 higher data rates, lower latency, massive connectivity, and device miniaturization, dielectric
27 materials must possess precisely engineered properties: a high quality factor ($Q \times f$), a suitable
28 dielectric permittivity (ϵ_r) and a near-zero temperature coefficient of resonant frequency (τ_f) [1].
29 These requirements are becoming even more critical as operating frequencies extend from sub-6
30 GHz into the millimeter-wave (mm-wave) and sub-terahertz ranges [2]. However, achieving these
31 properties often requires high-temperature processing, which conflicts with the manufacturing
32 demands for cost-effective, co-firable technologies like low-temperature Co-fired ceramic (LTCC).
33 This creates a fundamental dilemma: how to reduce processing temperatures without sacrificing
34 performance. This review critically analyzes this core trade-off by exploring the three dominant
35 paradigms being pursued to resolve it: (i) extrinsic modification through sintering aids, (ii) the
36 design of intrinsically low-sintering-temperature compounds, and (iii) radical process innovation
37 via cold sintering process (CSP). Figure 1 provides a schematic overview of the key challenges
38 and strategies discussed in this review, starting from the increasing technological demands, the
39 limitations of conventional ceramic sintering, and the emerging strategies developed to overcome
40 these issues, ultimately leading to the realization of LTCC.

41 In these higher frequency bands, designers face severe constraints due to greater signal
42 attenuation, reduced propagation distances, and the need for denser base station deployment.
43 Microwave dielectric ceramics are crucial for meeting these demands, serving as the foundation
44 for essential passive components like resonators, filters, and antennas in modern communication
45 systems [3, 4]. There are numerous studies reported on the development of microwave dielectric

46 properties. For example, minimizing intrinsic and extrinsic loss to achieve high $Q \times f$ [5-8], tuning
47 temperature coefficient of resonant frequency (τ_f) by making the crystal structure distorted [9] or
48 compensated by opposite sign of τ_f [10, 11]. Intrinsic losses are inherent to the material's crystal
49 lattice and its atomic vibrations called phonons. Materials with highly symmetrical, ordered, and
50 rigid crystal structures tend to have lower intrinsic losses [12]. The theory of intrinsic dielectric
51 loss in perfect crystals, developed by Gurevich and Tagantsev [12, 13], describes how anharmonic
52 interaction of an alternating electric field with the phonon system leads to energy dissipation; this
53 intrinsic loss is strongly dependent on crystal symmetry, with higher symmetry generally resulting
54 in lower loss. Disruptions in the crystal lattice, such as cation or anion vacancies, interstitials, or
55 lattice distortions, increase phonon scattering and lead to higher loss. Any deviations in the
56 stoichiometric ratio can create defects. Thus, precise material preparation is necessary [14].
57 Moreover, another technique to minimize intrinsic loss is finding materials composed of light ions
58 with strong ionic or covalent bonds. These materials tend to have high intrinsic phonon frequencies,
59 typically in the infrared range. Because these frequencies are much higher than microwave
60 frequencies, there is a poor energy coupling between the electromagnetic wave and the lattice
61 vibrations. This inefficiency in absorbing microwave energy results in very low dielectric loss.
62 [15-17]. Extrinsic losses are related to imperfections and non-idealities introduced during the
63 ceramic processing, such as density of samples, impurities, second phases, defects, and
64 microstructures [1, 4, 18-20]. These are often more controllable than intrinsic losses.



65

66 **Fig. 1** A schematic overview illustrating the progression from the technological demands of
 67 5G/6G communication to the development of LTCC. The figure highlights the challenges of
 68 conventional high-temperature sintering and presents the advanced strategies including chemical
 69 modification, material design, and process innovation that enable the integration of ceramics with
 70 low-cost metal electrodes.

71 State-of-the-art microwave dielectric ceramics such as $\text{BaZn}_{1/3}\text{Ta}_{2/3}\text{O}_3$, $\text{Ba}(\text{Mg}_{1/3}\text{Ta}_{2/3})\text{O}_3$,
 72 and other perovskites can achieve outstanding dielectric performance [21-23]. Yet, they require
 73 sintering temperatures above 1200°C – 1500°C [24, 25]. High sintering temperatures pose three
 74 critical challenges to ceramic manufacturing. First, the prolonged firing at high temperatures
 75 consumes substantial energy and extends processing cycles, which directly raises production
 76 costs. Second, these high temperatures exceed the melting points of widely used conductors like
 77 silver (Ag) [4, 26-30]. This can result in preventing the ceramics from being co-fired with metal
 78 electrodes. This forces manufacturers to use more costly, multi-step post-metallization processes.
 79 Finally, high-temperature processing can compromise the material itself. It may cause the

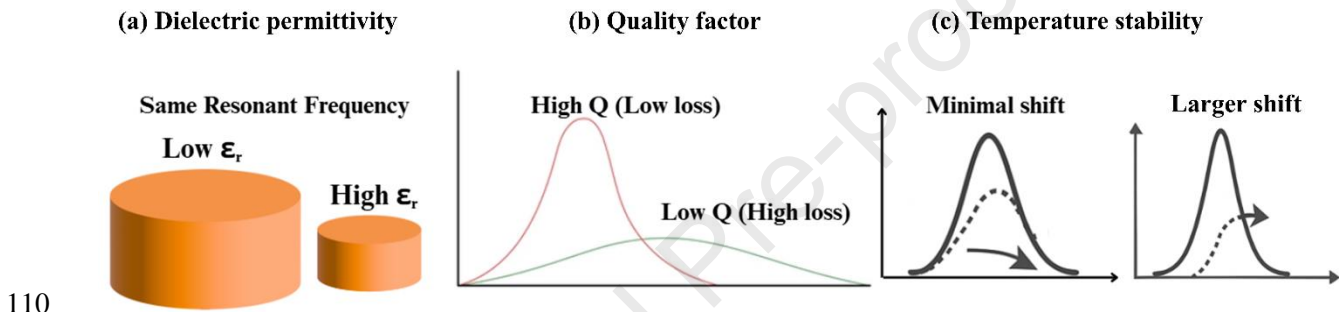
80 volatilization of constituent elements (such as Li, Pb, Te, and V), lead to phase decomposition,
81 and result in excessive grain growth and other microstructural defects, all of which ultimately
82 degrade the ceramic's dielectric properties.

83 Recent comprehensive reviews have further consolidated our understanding of CSP. H.
84 Palneedi *et al.* [31] systematically examined the effects of CSP process parameters (temperature,
85 pressure, dwell time, solvent type) on densification and grain growth, providing a quantitative
86 framework for process optimization. C. Liu *et al.* [32] reviewed recent advances in LTCC,
87 ULTCC, and CSP technologies for next-generation electronics, highlighting how these ultra-low-
88 temperature processing routes enable co-integration with silicon chips, aluminum electrodes, and
89 polymers. In response to these challenges, significant research has focused on developing low-
90 temperature processing strategies for microwave dielectric ceramics that do not compromise their
91 dielectric properties. This review examines three major routes that have emerged to achieve this
92 goal. First, the use of sintering aids and glass additives promotes liquid-phase densification at
93 lower temperatures, though this requires a careful balance to avoid introducing unwanted
94 secondary phases and increasing dielectric loss. Second, the development of intrinsically low-
95 sintering-temperature ceramic compounds such as those with lithium-based rock-salt, spinel, and
96 olivine structures. These systems can provide low densification temperatures below 950°C which
97 makes them compatible with silver co-firing. The third and final approach is the CSP. This
98 process is an ultra-low-temperature consolidation technique that uses transient liquid phase and
99 applied external pressure to achieve high density through dissolution-precipitation mechanisms.
100 Across these three categories, we address the fundamental mechanisms by which the sintering
101 temperature is reduced, the critical trade-offs between densification temperature and key
102 dielectric properties ($Q \times f$, ϵ_r and τ_f). and the detailed relationships among processing,

103 microstructure, and properties that inform effective material design. Finally, we discuss the
 104 industrial implications of these methods for scalability, reliability, and cost-effectiveness.

105 2. Fundamental principles of microwave dielectric ceramics

106 The required properties for microwave dielectric materials are determined by three important
 107 factors: a) the dielectric permittivity (ϵ_r), b) the quality factor ($Q \times f$), and c) the temperature
 108 coefficient of resonant frequency (τ_f) (Fig. 2). The roles and property enhancements of the
 109 materials will be described in the following sections.



110
 111 **Fig. 2** Conceptual illustration of the three key requirements for high-performance microwave
 112 dielectric ceramics. (a) Dielectric permittivity (ϵ_r): a high ϵ_r allows for device miniaturization, as
 113 a smaller resonator can achieve the same resonant frequency. (b) Quality factor ($Q \times f$): a high
 114 $Q \times f$ value, corresponding to low dielectric loss, is represented by a sharp and narrow resonant
 115 peak, indicating high frequency selectivity. (c) Temperature coefficient of resonant frequency
 116 (τ_f): a near-zero τ_f is required for thermal stability, ensuring a minimal shift of the resonant peak
 117 with temperature changes.

118 2.1 Dielectric permittivity (ϵ_r)

119 When a dielectric material is exposed to electromagnetic waves, the oscillating electric field
 120 induces a corresponding polarization within the material. This interaction can cause the material
 121 to resonate at specific frequencies, depending on its dielectric properties. The dielectric

122 permittivity of the material influences the propagation velocity of electromagnetic waves through
123 it, which can effectively shorten the wavelength within the material. The wavelength inside
124 dielectric material is the reciprocal of the square root of dielectric permittivity as the given
125 equation.

$$126 \quad \lambda_d = \frac{\lambda_0}{\sqrt{\epsilon_r}} \quad (1)$$

127 where λ_d is the wavelength in dielectric material, λ_0 is the wavelength in vacuum and ϵ_r is the
128 dielectric permittivity of the material. By increasing the permittivity of a resonator, its physical
129 size can be reduced without compromising its resonant frequency. This property allows for the
130 miniaturization of microwave components. The dielectric permittivity determines the propagation
131 velocity of electric signals through a dielectric material. Materials with low dielectric permittivity
132 enable high-speed signal transmission, while those with high permittivity are advantageous for
133 miniaturization. It is important to note that dielectric permittivity is frequency dependent. At
134 microwave frequencies, the net dipole moment and polarization are primarily influenced by ionic
135 and electronic polarization mechanisms. The dielectric constant is a function of relative density,
136 which is influenced by porosity. Furthermore, the unit cell volume, which determines the
137 polarizability of the material, also contributes to the dielectric constant.

138 **2.2 Quality factor ($Q \times f$)**

139 The quality factor, often expressed as $Q \times f$ (Q multiplied by resonant frequency in GHz), is a
140 function of resonant frequency. This frequency is determined by the puck's dimensions and the
141 material's permittivity and surrounding environment. It is determined from the shape of the
142 resonant peak and can be measured by calculating the ratio between the resonant frequency (f_0)
143 to the width of resonant frequency peak (Δf). The high Q materials are represented as the sharp
144 resonant frequency peak which provide the quality factor can be represented by the inversely

145 proportional to the loss tangent ($\tan \delta$) of the dielectric materials, where a higher Q indicates
146 lower energy loss. To obtain high Q for the millimeter wave application, it is necessary to use the
147 ultra-low loss materials. The correlation between loss tangent and the resonant frequency can be
148 ascribed in the term of $Q \times f$ product and it should be high ($Q \times f > 100$ THz) for the 5G technology.

149 The dielectric loss of the materials is the sum between intrinsic and extrinsic losses. Intrinsic
150 dielectric losses occur within perfect crystals due to the interaction between the phonon system
151 and the alternating electric field. When the ac field come to dielectric crystal, it alters the
152 equilibrium of the crystal system leading to the energy dissipation [12]. The extrinsic losses
153 originate from the quality of the specimens include the relative density, microstructure,
154 impurities, and defects [20, 21]. To obtain ultra-low loss materials, starting materials with
155 minimal dipole and charge carrier concentrations, as well as low carrier mobility, are essential.
156 Additionally, minimizing crystal lattice disorder, which arises from deviations in charge
157 distribution, helps reduce dielectric loss [33, 34]. Microwave dielectric ceramics are
158 conventionally fabricated through solid-state reaction. Sintering parameters, such as temperature
159 and time, also influence the microstructure and densification of the ceramic which affects its
160 microwave dielectric performance. The dielectric loss is frequency dependent, generally
161 increasing as frequency is elevated. This behavior is governed by two main mechanisms: intrinsic
162 loss from the interaction with lattice phonons, and extrinsic loss introduced by crystal defects and
163 impurities. Both mechanisms typically contribute more to the total loss at higher frequencies
164 [35]. The ($Q \times f$) of a dielectric material is fundamentally limited by its defect density. In practice,
165 low-frequency resonators require larger sample dimensions. These larger samples have a higher
166 statistical probability of containing performance-limiting defects, making it more challenging to
167 consistently achieve the material's intrinsic $Q \times f$ during production and measurement. Conversely,

168 smaller, high-frequency resonators are less susceptible to these volume-dependent statistical
169 variations, often resulting in more reliable and consistent measurement outcomes.

170 **2.3 Temperature stability**

171 Microwave dielectric materials must operate reliably over a wide temperature range, typically
172 from $-40\text{ }^{\circ}\text{C}$ to $+110\text{ }^{\circ}\text{C}$, under various environmental conditions. τ_f is a critical parameter that
173 quantifies the stability of the resonant frequency against these temperature variations. Materials
174 with a large τ_f value are unsuitable for most microwave applications as they fail to maintain
175 frequency stability under thermal fluctuations [36]. To achieve a near-zero τ_f , it is necessary to
176 understand its origin. The τ_f value is determined by the net effect of two competing factors: the
177 coefficient of thermal expansion (α_L), which alters the resonator's physical dimensions, and the
178 temperature coefficient of the dielectric constant (τ_ε) which describes the change in permittivity
179 with temperature. Their combined influence is expressed in the following equation:

$$180 \quad \tau_f = -\left(\alpha_L + \frac{\tau_\varepsilon}{2}\right) \quad (2)$$

181 Oxide ceramics play a pivotal role in the performance of microwave devices. A thorough
182 understanding of their crystal chemistry is essential for ongoing research and development. The
183 properties of microwave ceramics are influenced by several factors, including processing
184 conditions, the purity of starting materials, and the final density achieved through sintering. The
185 design of optimized heating and cooling schedules requires a deep understanding of the formation
186 mechanisms of different phases within complex multicomponent systems. Furthermore, the
187 properties tuning such as the permittivity, quality factor and temperature coefficient of resonant
188 frequency is achievable by adding some elements into the crystal structure. There are several
189 ceramic compounds that have been paid attention to. They can be categorized by the crystal
190 structure, for example, perovskite, tungsten bronze, and, cubic rock salt [18, 37].

191 The pursuit of low-temperature densification is fundamentally governed by thermodynamic
192 and kinetic drivers, namely, grain-boundary energy minimization and the reduction of diffusion
193 activation barriers, and by defect chemistry that controls dielectric loss and τ_f stability. In
194 practice, these physical levers map directly onto material-design choices: liquid-phase routes
195 (*e.g.*, glass or sintering aids) lower the effective sintering barrier via capillary-assisted
196 rearrangement and solution-precipitation; intrinsically low- T_S chemistries (*e.g.*, Li-containing
197 rock-salt, spinel, olivine families) exploit fast ionic mobility and weaker lattice bonding to
198 accelerate solid-state diffusion while preserving high $Q \times f$; and CSP invokes a transient solvent
199 under pressure to enable dissolution-precipitation at $<200^\circ\text{C}$, followed by targeted post-anneals
200 to heal defects and suppress residual OH^- -related loss. Framed in the process–structure–property
201 logic, each route engineer grain-boundary complexion and point-defect populations to achieve
202 the same objective: high density with clean interfaces and minimal extrinsic losses at the lowest
203 possible thermal budget. The following sections apply this mechanistic lens to compare these
204 strategies and to articulate the design trade-offs among T_S – $Q \times f$ – ε_r – τ_f and co-firing compatibility.

205 **3. A brief history of microwave dielectric ceramics**

206 The development of microwave dielectric ceramics has been inextricably linked to the
207 evolution of wireless communication technologies over the past five decades. The progression
208 from analog to digital networks, and from lower to higher operating frequencies, has continuously
209 driven innovation in materials with increasingly demanding performance specifications.

210

211

212 **3.1 Early developments and the foundation period (1960s–1970s)**

213 The origins of microwave dielectric research can be traced to the 1960s and 1970s, when the
214 first-generation (1G) analog mobile communication systems began to emerge. During this
215 pioneering era, researchers explored fundamental ceramic systems that would later become
216 commercially significant. Among the earliest materials investigated were titanates and simple
217 binary oxide systems. The BaO-TiO₂ system received particular attention, with comprehensive
218 phase diagram studies in the 1970s revealing multiple stable compounds, including BaTi₄O₉ and
219 Ba₂Ti₉O₂₀ [38, 39]. These barium polytitanates would eventually become cornerstone materials
220 for commercial microwave devices due to their moderate dielectric constants ($\epsilon_r \sim 37\text{--}40$) and
221 acceptable quality factors ($Q \times f \sim 30,000\text{--}40,000$ GHz), though their high sintering temperatures
222 exceeding 1300°C presented significant manufacturing challenges [40, 41].

223 Parallel investigations during this period examined the ZrTiO₄ system, which demonstrated
224 promising microwave characteristics with $\epsilon_r \sim 40\text{--}42$ and $Q \times f \sim 28,000\text{--}31,000$ GHz at 7 GHz [42,
225 43]. However, its large positive temperature coefficient ($\tau_f = +58$ ppm/°C) and extremely high
226 sintering temperature ($\sim 1600^\circ\text{C}$) limited immediate practical applications. Researchers
227 discovered that partial substitution of Zr⁴⁺ with Sn⁴⁺ to form (Zr,Sn)TiO₄ (ZST) ceramics
228 successfully achieved near-zero temperature coefficients while maintaining excellent microwave
229 properties, with $Q \times f$ values reaching 53,000–61,000 GHz [44].

230 **3.2 The breakthrough era: complex perovskites (late 1970s-1980s)**

231 In 1977, Kawashima *et al.* reported that Ba(Zn_{1/3}Ta_{2/3})O₃ (BZT) exhibited exceptionally high
232 $Q \times f$ at microwave frequencies [44]. This discovery triggered intensive research into complex
233 perovskites (ABO₃) with B-site cation ordering. Throughout the 1980s, “super Q ” materials such
234 as BZT and Ba(Mg_{1/3}Ta_{2/3})O₃ (BMT) achieved $Q \times f$ exceeding 150,000 GHz, among the highest

235 ever reported. These 1:2 ordered perovskites (trigonal, space group $P-3m1$) offered $\epsilon_r \sim 28-30$ and
236 good thermal stability [45-47].

237 However, practical implementation faced severe obstacles. Achieving optimal cation ordering
238 required prolonged annealing at 1400–1450°C after initial sintering at 1600–1650°C, causing
239 high energy consumption, B-site cation volatilization, and incompatibility with low-melting-point
240 electrode metals such as silver (melting point=961°C) [45, 46, 48].

241 **3.3 Adaptation to digital networks (1990s-early 2000s)**

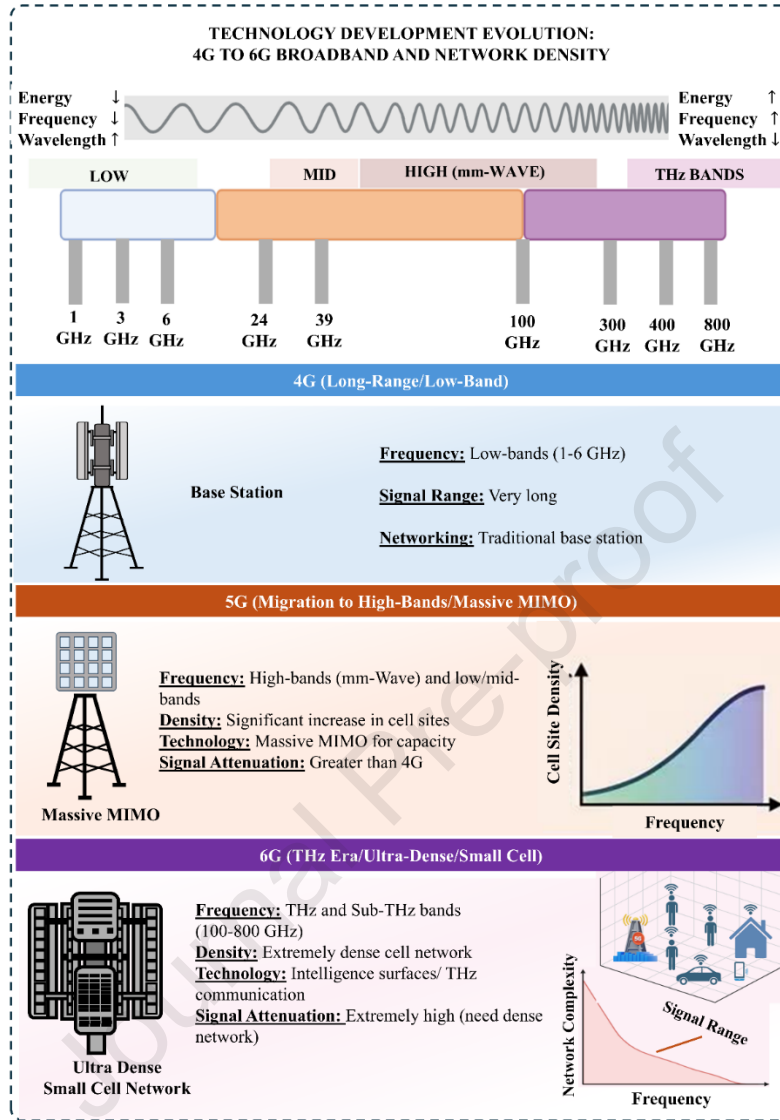
242 The transition from 1G analog to 2G/3G digital networks demanded better frequency
243 selectivity [49]. Materials research diversified to tungstates, niobates, and BaO-Ln₂O₃-TiO₂
244 systems [39].

245 Three main strategies emerged to reduce sintering temperatures while preserving dielectric
246 performance: (i) liquid-phase sintering using additives (CuO, Bi₂O₃, B₂O₃, V₂O₅, or low-melting
247 glasses), (ii) chemical processing (sol-gel, co-precipitation, hydrothermal) to enhance powder
248 reactivity, and (iii) the development of LTCC technology (pioneered in 1982, commercialized in
249 the 1990s), which lowered firing temperatures below 900–1000 °C by incorporating glassy
250 phases, enabling co-firing with silver and copper electrodes [38, 47, 50]. Furthermore, the
251 challenge of achieving near-zero temperature coefficients of resonant frequency received
252 systematic attention. Researchers established that τ_f could be engineered through composite
253 approaches combining materials with opposing temperature coefficients or through solid solution
254 formation, exploiting the relationship $\tau_f = -(\alpha_L + \frac{1}{2}\tau_\epsilon)$ where α_L represents linear thermal expansion
255 and τ_ϵ is the temperature coefficient of permittivity. These strategies enabled optimization of
256 temperature stability without sacrificing other critical properties [51-53].

257

258 **3.4 Modern era: toward 4G, 5G, and beyond (2000s-present)**

259 4G LTE (operating above 3 GHz) accelerated the need for smaller components with higher
260 $Q \times f$ and improved temperature stability [54]. The arrival of 5G expanded the spectrum into
261 sub-6 GHz and millimeter-wave bands (20–40 GHz), demanding ceramics that are compact,
262 ultra-low loss ($\tan \delta < 10^{-4}$), thermally stable ($\tau_f \sim 0$ ppm/°C), and cost-effective for mass
263 production. Looking ahead, 6G systems will operate in the sub-terahertz range (0.1–1 THz),
264 requiring not only superior intrinsic properties but also compatibility with heterogeneous material
265 integration and energy-efficient manufacturing [54, 55]. The detailed technological evolution and
266 development pathways from 4G toward 6G networks, characterized by shifting operational
267 frequencies, changing cell site densities, and structural modifications, are illustrated in Fig. 3.



268

269 **Fig. 3** An overview of the progression of wireless communication technologies and their associated
 270 frequency bands, from 4G, 5G and 6G spectrum. The figure also represents the inverse relationship
 271 between frequency and wavelength, alongside the typical base station designs and the increasing
 272 signal attenuation challenges at higher frequencies.

273 3.5 The Paradigm Shift: Ultra-Low Temperature Processing

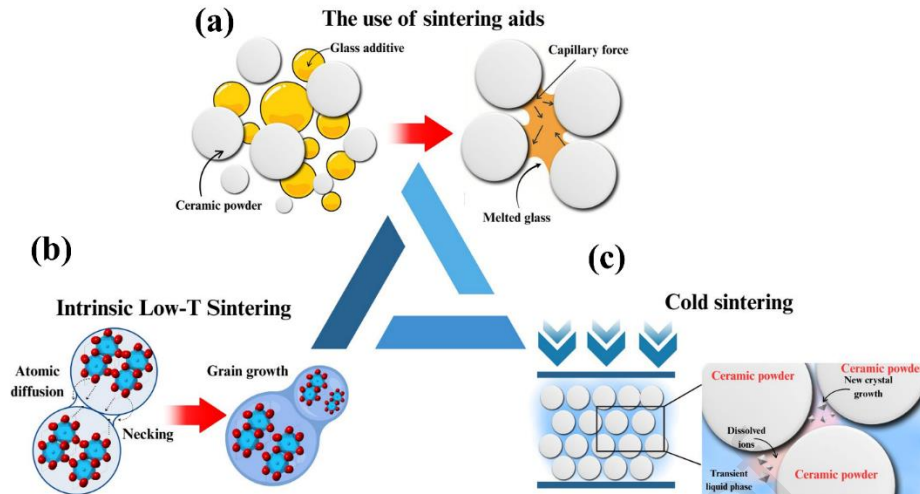
274 While conventional high-temperature sintering (1200–1600 °C) yields excellent dielectric
 275 properties, it suffers from high energy consumption, volatile element loss, and incompatibility

276 with low-melting-point electrodes such as silver (melting point 961 °C). A major breakthrough
277 came in 2016 when Randall and co-workers introduced CSP [56, 57]. This technique achieves
278 ceramic densification at temperatures below 300 °C (often as low as room temperature) by
279 applying a transient aqueous solution under uniaxial pressure, enabling dissolution-precipitation
280 without high thermal energy. CSP dramatically reduces energy consumption and allows
281 co-sintering with polymers and low-melting-point metals, opening new avenues for
282 multifunctional devices [58].

283 Meanwhile, LTCC technology (sintering below 900–1000 °C) has matured commercially,
284 becoming the mainstream platform for miniaturized multilayer RF modules [59]. The detailed
285 mechanisms, material examples, and performance trade-offs of these low-temperature strategies
286 are examined in Sections 4 and 8.

287 **4. Low-temperature sintering techniques: materials and mechanisms**

288 In addition to optimizing intrinsic dielectric properties, reducing the sintering temperature is
289 a critical factor for enabling cost-effective manufacturing and co-integration with low-cost metal
290 electrodes like silver (< 961 °C). Conventional ceramic processing, often requiring temperatures
291 exceeding 1200 °C, is energy-intensive and can lead to detrimental effects such as the
292 volatilization of constituent elements. Consequently, significant research has focused on three
293 primary strategies to lower the densification temperature, as illustrated in Fig. 4: (a) the utilization
294 of external sintering aids, (b) the design of intrinsically low-sintering-temperature compounds,
295 and (c) the application of innovative pressure-assisted cold sintering processes. This section
296 provides a detailed review of the materials and mechanisms central to each of these approaches
297 [29, 46, 60].



298

299 **Fig. 4** An overview of the three primary strategies for achieving low-temperature densification of
 300 microwave dielectric ceramics, as discussed in this review. (a) The use of sintering aids, such as
 301 glass additives, which form a liquid phase to facilitate particle rearrangement via capillary forces.
 302 (b) Intrinsic low-temperature sintering, where materials possess inherent properties (*e.g.*, high
 303 atomic mobility) that allow for solid-state densification at lower temperatures. (c) CSP, an
 304 innovative technique that utilizes a transient liquid phase and external pressure to achieve
 305 densification at ultra-low temperatures through a dissolution-precipitation mechanism.

306

307

308 4.1 Sintering aids: the liquid-phase sintering approach

309 4.1.1 Mechanism of liquid-phase sintering

310 Several approaches have been employed to reduce the sintering temperature of low-loss
 311 microwave dielectric materials. These strategies can be broadly categorized: some focus on
 312 modifying the primary ceramic powder, such as using chemical synthesis to produce fine-grained
 313 starting particles [61] or the use of smaller starting particles [62], while others involve
 314 incorporating a low-melting-point additive. Among the latter, the addition of glass is a particularly

315 effective and economical strategy. This approach utilizes a mechanism known as liquid-phase
316 sintering (LPS). Depending on the glass composition, two main outcomes are possible: the
317 additive can either remain as a residual amorphous phase in the final sintered ceramic, or it can
318 be designed to crystallize during the sintering process. Due to its versatility and cost-
319 effectiveness, the glass addition method is one of the most widely investigated strategies. Glasses
320 are selected as sintering aids due to their significantly lower softening and melting temperatures
321 compared to crystalline ceramics. During heating, the glass additive melts to form a liquid phase
322 that wets and surrounds the solid ceramic particles. This liquid phase dramatically accelerates the
323 densification process, which is much slower in conventional solid-state sintering where
324 densification relies solely on atomic diffusion within the solid. The mechanism of liquid-phase
325 sintering proceeds through several stages. Initially, the capillary force generated at the liquid-
326 solid interface pulls the particles together into a denser arrangement, reducing interparticle
327 porosity [63]. Following this, the liquid acts as a rapid transport medium for a process known as
328 solution-precipitation. This stage involves several distinct steps. First, atoms from the surface
329 of the primary ceramic particles dissolve into the liquid phase. These dissolved atoms then diffuse
330 through the liquid. Finally, they precipitate onto the contact points, or 'necks', between adjacent
331 particles. This precipitation causes the necks to grow, pulling the particles closer and leading to
332 further densification. In some systems, this can also lead to significant grain growth. Finally, the
333 remaining liquid flows into and fills the residual pores, resulting in a highly densified ceramic
334 product.

335 **4.1.2 Primary and multi-component glass systems**

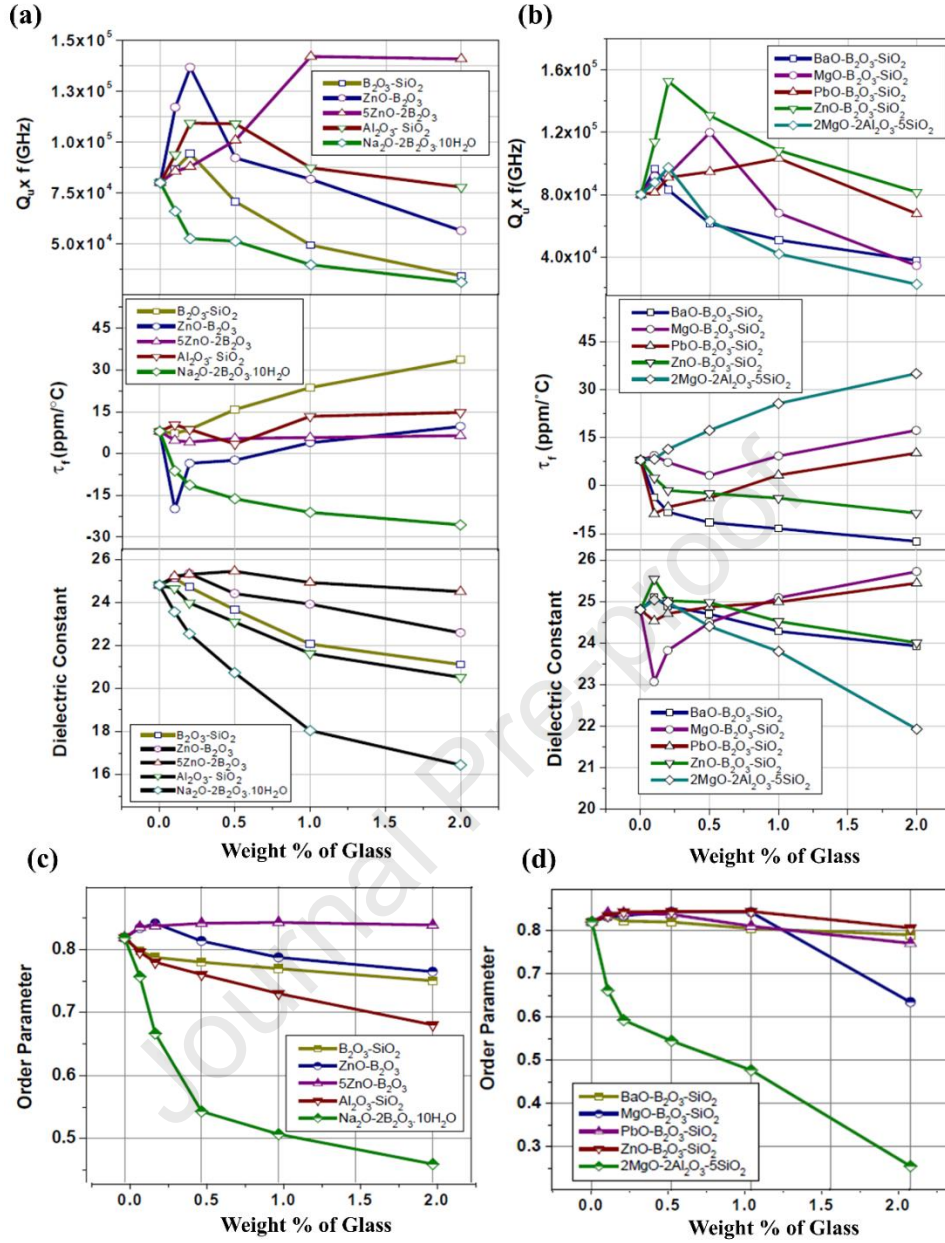
336 Multi-component glasses have been shown to be an alternative way in reducing the sintering
337 temperature of ceramics, while minimizing the detrimental effects on the matrix properties [4].

338 Choosing the right glass phase is crucial for the sintering process, as its liquification plays a
339 dominant role in the viscous flow mechanism that governs densification. Simple binary oxide
340 glasses, particularly borate (B_2O_3) and silicate (SiO_2) glasses, are the most widely used additives
341 in microwave dielectric ceramics. However, their effectiveness is dictated by their distinct
342 thermophysical properties. B_2O_3 glass, with its very low glass transition temperature ($T_g \sim 230$ –
343 $325^\circ C$) and low viscosity, forms a pervasive liquid phase at a much lower temperature compared
344 to SiO_2 -based glasses ($T_g > 1000^\circ C$). This low-viscosity liquid phase significantly enhances
345 particle rearrangement through strong capillary forces and accelerates mass transport via
346 dissolution-precipitation, leading to a substantial reduction in the required sintering temperature
347 [63, 64].

348 For example, in the $Ca_5Nb_2TiO_{12}$ system, the addition of borate glass was shown to
349 promote densification without forming secondary phases at 1 wt% loading [65]. However, the
350 effectiveness of these additives is a delicate balance. The degradation of dielectric properties,
351 particularly the $Q \times f$ value, with excessive glass content is attributed to two primary loss
352 mechanisms. First, the residual amorphous glass phase, which tends to segregate at grain
353 boundaries, is inherently lossier than the crystalline ceramic matrix. Its disordered structure
354 increases phonon scattering and introduces a continuum of energy states that dissipate microwave
355 energy. Second, when the solubility limit of the ceramic matrix in the molten glass is exceeded,
356 secondary phases such as $Ca_3B_2O_6$ or Ca_2SiO_4 can precipitate [66, 67]. The addition of a sintering
357 aid, such as glass, is an effective strategy to reduce the high sintering temperatures of ceramics
358 from $1500^\circ C$ – $1650^\circ C$ down to around $1350^\circ C$ [68]. However, this benefit comes with a trade-
359 off, as these additive phases also degrade the microwave dielectric properties. They introduce
360 additional interfaces and potentially lossy crystal structures, which disrupt the overall lattice

361 perfection and increase the intrinsic dielectric loss. Therefore, the amount of the additive must be
362 carefully optimized, confirming why a precise, often small, quantity is crucial for achieving
363 optimal performance.

364 For a well-known $\text{Ba}(\text{Mg}_{1/3}\text{Ta}_{2/3})\text{O}_3$ (BMT) ceramic, glass addition has also been proposed
365 as a method to decrease its sintering temperature. It is recognized that the microwave dielectric
366 properties of BMT are influenced by ordered-disordered effects. Specifically, B-site cation
367 ordering of Mg^{2+} and Ta^{5+} is the fundamental requirement for high quality-factor in complex
368 perovskite BMT ceramics. The primary challenge with solid-state sintering of BMT is its
369 exceptionally high sintering temperature which is higher than $1600\text{ }^\circ\text{C}$. Moreover, achieving an
370 ordered phase of BMT necessitates prolonged annealing, often extending to several days which
371 may lead to the volatilization of some elements in the compound. Thus, secondary phases are
372 possibly formed, for example, BaTa_2O_6 and $\text{Ba}_5\text{Ta}_4\text{O}_{15}$ [69, 70]. Borate glass (B_2O_3) can be used
373 for lowering the sintering temperature of BMT ceramics from 1600°C to 1325°C . The addition of
374 silica does not lower the sintering temperature like in borate glass because its softening point is
375 relatively high [71]. Although silica has high melting temperature ($T_m \sim 1700\text{ }^\circ\text{C}$) [71] which
376 making it unsuitable as a standalone sintering aid. However, it can form stable low-melting
377 temperature glass compounds when blended with other oxides (*e.g.*, B_2O_3 , ZnO , PbO , BaO , Bi_2O_3 ,
378 Li_2O_3 , MgO , etc). These resultant glass compounds can then be effectively employed as sintering
379 aids [72-75]. In BMT ceramics, silica can promote the abnormal grain growth of the sintered
380 ceramic as reported by Felgner [76]. This abnormal grain growth leads to the high porosity in the
381 sintered ceramics. The degree of ordering is minimally influenced by the borate-added system,
382 while the substantial impact is observed in the silicate system. This results in the deterioration of
383 microwave dielectric properties of BMT ceramics as the silicate glass is added (Fig. 5) [77].



384

385 **Fig. 5** Microwave dielectric properties of BMT ceramics as a function of weight% of glass
 386 additives. (a) two-component glass compounds, (b) three-component glass compounds. Variation
 387 of cation ordering of BMT ceramics as a function of glass additive amount of (c) two-component
 388 glass compounds, and (d) three-component glass compounds [77].

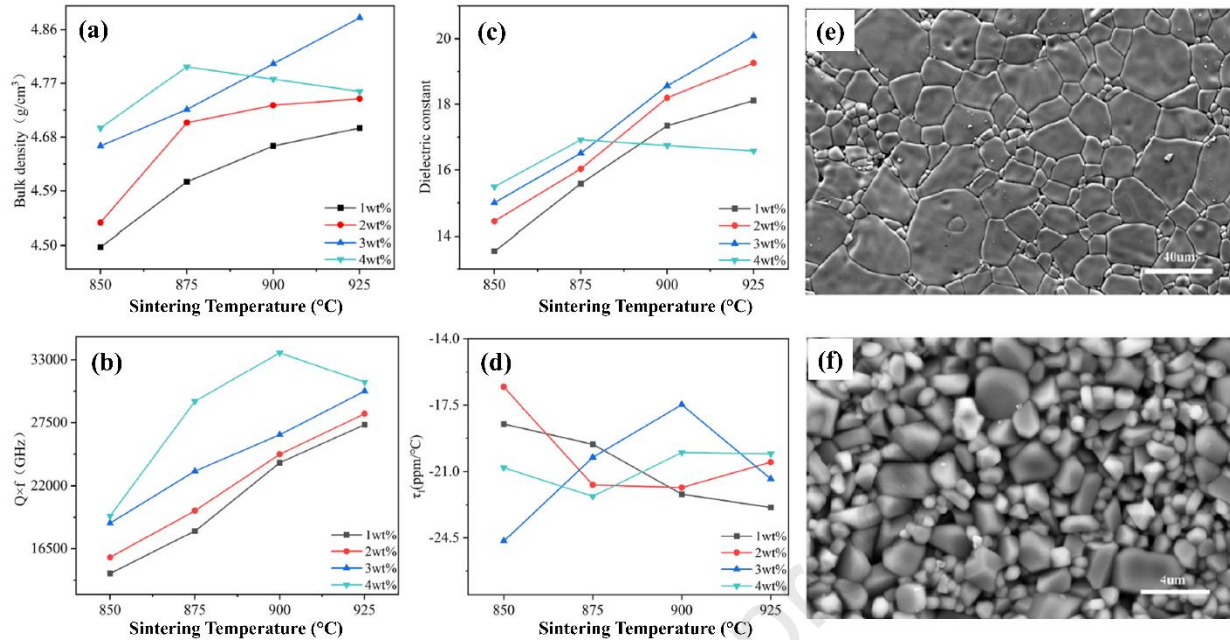
389

390

Takada *et al.* demonstrated the effects of two primary glasses contents (B_2O_3 and SiO_2) on
 BaO-TiO₂-WO₃ [78] and (Zr, Sn)TiO₄ [79] microwave ceramics. As the glass content has risen

391 from 5wt% to 30wt%, the density of ceramic also increases. Sintering temperature of the ceramics
392 decreases to around 1000 °C–1100 °C with 80%–85% of relative density. However, the added
393 glass phases react with the ceramic phase leading to the lowering in microwave dielectric features.
394 As a reminder, the sintering temperature for LTCC technology must not exceed the melting point
395 of the metal electrodes. This limitation makes determining the appropriate glass compounds to
396 lower the sintering temperature of such ceramics a persistent challenge.

397 Some ceramic compounds can approach the low sintering temperature by the addition of
398 glasses, for example, the τ_f compensator $\text{Ba}_5\text{Nb}_4\text{O}_{15}$ (BNO) ceramic. It was reported that borate
399 glass can reduce the sintering temperature of BNO from 1450 °C down to 925 °C [80]. Furthermore,
400 boric acid (H_3BO_3), a form of boron-containing compound, serves as a B_2O_3 sintering aid for
401 various ceramic compounds. It can lower the sintering temperature of various ceramics such as,
402 $\text{Li}_2\text{Mg}_3\text{Ti}_{0.95}(\text{Mg}_{1/3}\text{Nd}_{2/3})_{0.05}\text{O}_6$ (from 1550 °C to 1000 °C) [81], $\text{Li}_2\text{ZnTi}_3\text{O}_8$ (from 1075 °C to 880
403 °C) [82] and composite $0.8\text{BaSi}_2\text{O}_5\text{-}0.2\text{Ba}_3(\text{VO}_4)_2$ (from 1140 °C to 950 °C) [83]. Several reports
404 indicate that the reduction in densification temperature is most practically attributed to enhanced
405 liquid-phase diffusion through grain boundaries. This liquid phase facilitates grain recrystallization
406 and rearrangement, which in turn eases the diffusion of trapped gases. Thus, it ultimately leads to
407 a more compact microstructure [84, 85]. Like mostly glass additives, after the amount of H_3BO_3
408 increases, the quality factor of the sintered ceramics also decreases. Achieving a high $Q \times f$ and a
409 low sintering temperature simultaneously was thus a challenging task. Yan *et al.* tried to lower the
410 sintering temperature of $\text{Co}_{0.1}\text{Zn}_{0.9}\text{TiO}_4$ ceramics by adding H_3BO_3 . The sintering temperature
411 could be reduced from 1200 °C to 900 °C using 4 wt% of H_3BO_3 as a sintering aid. They suggested
412 that an excessive amount of glass additive leads to abnormal grain growth which affected the
413 quality factor of the ceramic (see Fig. 6) [86].



414
 415 **Fig. 6** (a-d) Microwave dielectric properties and bulk density of $\text{Co}_{0.1}\text{Zn}_{0.9}\text{TiO}_4$ ceramic at various
 416 contents of H_3BO_3 as a function of sintering temperature. (e,f) Microstructure of (e) traditional
 417 sintered $\text{Co}_{0.1}\text{Zn}_{0.9}\text{TiO}_4$ ceramic and (f) 4 wt% of H_3BO_3 addition [86].

418 It is noted that the sintering temperatures of the compounds mentioned earlier remain
 419 within a critical threshold (within $900\text{ }^\circ\text{C}$), which could lead to reactions with the silver electrodes.
 420 The microwave dielectric properties also deteriorated as secondary phases were detected. This
 421 observation is consistent with other borate-based compounds, even when sintering temperatures
 422 were lowered to less than $900\text{ }^\circ\text{C}$ [87-92].

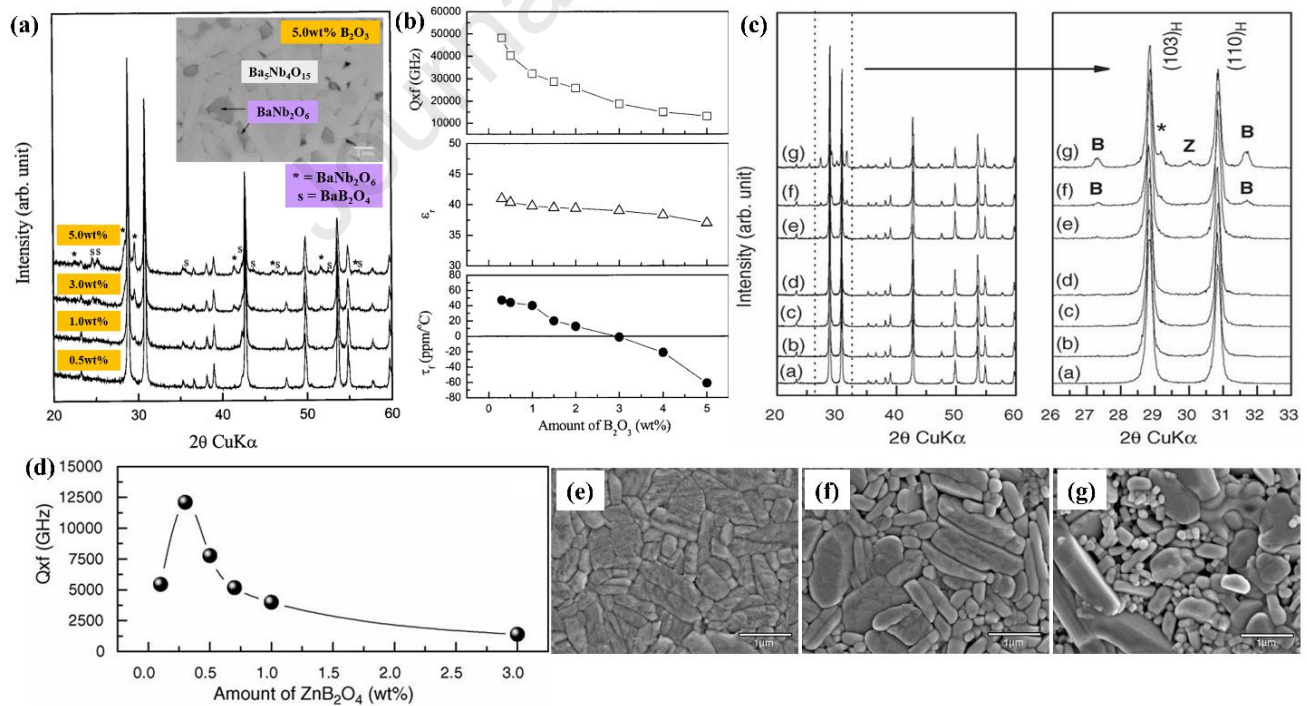
423 Glass additives with more than one component have been proposed to lower the sintering
 424 temperature of ceramics with high density products [60-61, 76]. Borosilicate glasses ($\text{B}_2\text{O}_3\text{-SiO}_2$)
 425 generally exhibit lower dielectric losses than alkali-containing glasses. In alkali-containing
 426 glasses (e.g., Li-, Na-, K-containing glass compounds), weakly bonded alkali ions can absorb
 427 energy, leading to increased dielectric loss. In contrast, borosilicate glasses possess a continuous
 428 network of SiO_4 and BO_3 units linked by strong Si–O–B bonds, resulting in higher electrical

429 resistance and lower dielectric loss which is reported by Navias [77]. Moreover, additional glass
430 as a sintering aid can lead to the existence of secondary phases. For the famous BMT ceramics,
431 the addition of MCAS glass to BMT lowered the sintering temperature to 1300 °C. However, this
432 resulted in a significant decrease in the $Q \times f$ value to 9700 GHz, making it unsuitable for
433 industrial production [78, 79]. Excessive glass addition can induce thermal stress during
434 soldering, leading to cracking due to the differential thermal expansion between the glass and
435 ceramic phases. Multi-component glass compounds are mostly based on the primary borate and
436 silica glasses. A small amount of glass compounds such as ZnO-B₂O₃, 5ZnO-2B₂O₃, ZnO-B₂O₃-
437 SiO₂ can reduce sintering temperature for BMT ceramics from 1650 °C down to 1300 °C with
438 desired relative density ($\rho \sim 98.7\%$) without any secondary phases. Furthermore, these glass
439 compounds enhance the degree of ordering of the B-site cations which improve the quality factor
440 of the BMT ceramics. The glass compound that promotes very good microwave dielectric
441 features in BMT ceramic is the ternary ZnO-B₂O₃-SiO₂ (ZBS) glass. It acts as a perfect liquid-
442 phase medium for the sintering of BMT when added just 0.2 wt% ($\epsilon_r = 25.5$ and $Q \times f = 152,800$
443 GHz, $\tau_f = -1.5$ ppm/°C) [77].

444 Kim *et al.* demonstrated the use of B₂O₃ as a sintering aid to lower the processing
445 temperature of Ba₅Nb₄O₁₅ (BNO) ceramics. While this additive successfully reduced the sintering
446 temperature from 1450 °C to 925 °C, it also led to the formation of a secondary phase at a glass
447 concentration of 1 wt% [80]. A similar limitation was observed when using a ZnB₂O₄ glass
448 system, where additions exceeding 1 wt% resulted in the formation of secondary phases such as
449 ZnB₂O₄, Ba₃B₂O₆ and ZnNb₂O₆ [92]. J. Tang [91] utilized BaO-B₂O₃-ZnO as a sintering aid for
450 Ba₅Nb₄O₁₅ ceramic. The study found that adding 6 wt% of BaO-B₂O₃-ZnO can lower the
451 sintering temperature from 1450°C to 850°C with relative density of 94.5%. The glass-added

452 ceramic showed $\text{Ba}(\text{Zn}_{0.33}\text{Nb}_{0.67})\text{O}_3$ phase as the secondary phase along with $\text{Ba}_5\text{Nb}_4\text{O}_{15}$ and the
 453 microwave dielectric properties were slightly deteriorated from the glass-free system ($\epsilon_r=37.1$
 454 and $Q \times f=13,820$ GHz) [91]. Thus, the amount of glass is required to optimize. However, using
 455 ternary glass additive such as $\text{BaCu}(\text{B}_2\text{O}_5)$ can lower the sintering temperature of $\text{Ba}_5\text{Nb}_4\text{O}_{15}$
 456 ceramic (T_s from 1450 °C to 875 °C) without any secondary phases while its microwave
 457 dielectric properties were improved [90]. The ternary $\text{MgO-B}_2\text{O}_3\text{-SiO}_2$ (MBS) is used as sintering
 458 aid in various ceramic compounds. Zhang *et al.* reported the effect of MBS glass content on the
 459 sintering temperature and microwave dielectric features of rock-salt $\text{Li}_3\text{Mg}_2\text{NbO}_6$ ceramic [75].
 460 $\text{Li}_3\text{Mg}_2\text{NbO}_6$ ceramic achieved satisfying microwave dielectric properties with the addition of
 461 0.5 wt% MBS glass. The sintering temperature decreased from 1250 °C to 925 °C, they displayed
 462 an ϵ_r of 14.5 , a $Q \times f$ of $80,759$ GHz, and a τ_f of -20.7 ppm/°C.

463



464

465 **Fig. 7** Low sintered $\text{Ba}_5\text{Nb}_4\text{O}_{15}$ ceramics using two types of glass additives (B_2O_3 and ZnB_2O_4).
466 (a) Phase formation and (b) microwave dielectric properties ($Q \times f$, ϵ_r , and τ_f) of sintered
467 $\text{Ba}_5\text{Nb}_4\text{O}_{15}$ ceramics as a function of B_2O_3 glass content (the inset of Figure 7(a) shows the
468 backscattered image of BaNb_2O_6 secondary phase). (c) Influence of ZnB_2O_4 glass content on
469 $\text{Ba}_5\text{Nb}_4\text{O}_{15}$ phase formation (where: $*$ = ZnB_2O_4 , B = $\text{Ba}_3\text{B}_2\text{O}_6$ and Z = ZnNb_2O_6 secondary phases)
470 and (d) $Q \times f$ values. (e-g) Microstructure of 0.3 wt%, 3 wt%, and 10 wt% of ZnB_2O_4 content,
471 respectively. (Adapted from D.W. Kim *et al.* [80] and J.R. Kim *et al.* [92])

472 While glass additives are effective in reducing sintering temperature, their impact on the
473 final microwave dielectric properties needs to be considered. As the glass phases themselves still
474 maintain in the ceramic or they can react with the pristine ceramic compound forming secondary
475 phases. These glasses and secondary phases directly affect microwave dielectric properties
476 especially to the quality factor. Some glass systems, the glass additive can aid for recrystallization
477 during the sintering process. This phenomenon forms a glass-ceramic composite. In the work by
478 J.Y. Qiu [93], they fabricated the borosilicate-based glass-ceramic. The results reveal that as the
479 amount of Li_2O is promoted into borosilicate glass, it acts as the crystallization catalysts [94].
480 The effects of glass additives on ceramic compounds are summarized in Table 1. While these
481 case studies demonstrate the potential of multi-component glass systems, the sheer complexity of
482 these systems, often involving three, four, or even more oxide components, presents a significant
483 challenge for traditional trial-and-error experimental approaches. This is where computational
484 materials science, particularly through the use of thermodynamic databases like CALPHAD
485 (calculation of phase diagrams), is becoming indispensable [95, 96]. By predicting phase stability
486 and the melting behavior of complex glass compositions, researchers can rapidly screen and
487 identify promising candidates for sintering aids before undertaking extensive experimental work.

488 Moreover, machine learning models trained on existing experimental data are now being
489 employed to predict the optimal glass composition that minimizes sintering temperature while
490 preserving the high $Q \times f$ value of the ceramic matrix, accelerating the discovery cycle for new
491 LTCC materials.

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492 **Table 1** Effects of glass additives on sintering temperature (T_s), microwave dielectric properties and limitations.

Type of sintering aid	ΔT_s (°C)	ϵ_r	$Q \times f$ (GHz)	τ_f (ppm/°C)	Advantages	Limitation
Borate glass	100-400	Slightly decreased	Slightly–moderately decreased	Can shift significantly (\pm)	Small amount of glass can provide dense ceramics without forming any second phases	Thermal instability
Silicate glass	50-200	Stable or slightly increased	Slightly decreased	Minor changes	Good chemical stability, adjustable composition	Limited solubility in some systems Increase dielectric loss from the residual glass
ZnO-B₂O₃-SiO₂ (ZBS) glass	200-400	Stable	Slightly decreased	Stable or adjusted toward zero	Good match with Ag/Pt with stable τ_f	ZnO volatility Moisture susceptibility
Li₂O-B₂O₃-SiO₂ (LBS) glass	200-300	Slightly decreased	Moderately decreased	Negligible	Good glass-ceramic compatibility, promotes densification	Li volatilization during sintering
Aluminosilicate glass	150-250	Stable	Slightly decreased	Minor changes	Good mechanical strength, chemical durability	Higher T_s than borate-based glass
Phosphate glass	250-350	Slightly decreased	Decreased	Can shift toward positive	Very low T_s , fast densification	Poor water resistance, limited thermal stability
Fluoroborate glass	300-400	Slightly decreased	Decreased	Minor changes	Low T_s , fluoride addition aids densification	Possible fluorine loss, phase instability
Bi₂O₃-based glass	300-400	Increased	Decreased	Shift toward negative	Very low T_s , improves liquid-phase sintering	Bi volatility, reaction with electrodes

493

494 **4.2 Intrinsically low-sintering-temperature compounds**

495 Beyond the use of external additives, a significant research thrust focuses on developing
496 ceramic compounds that inherently possess low sintering temperatures due to their unique crystal
497 chemistry and bonding characteristics.

498 **4.2.1 Lithium-containing systems: rock-salts and spinels**

499 The sintering temperature of a material is correlated with its melting point, which is a function
500 of the cohesive energy of the crystal lattice. The cohesive energy is influenced by factors such as
501 crystal structure, bond strength, and bond polarity [97]. Materials with weaker bonds and higher
502 bond polarity tend to have lower melting points and, consequently, lower sintering temperatures.

503 Lithium (Li)-containing compounds are vital in LTCC technology, distinct from the role of
504 glass additives. This ability stems from intrinsic properties related to lithium's unique
505 characteristics within specific crystal frameworks. The fundamental reason for their ability to
506 promote low-temperature densification lies in the enhanced solid-state diffusion kinetics enabled
507 by the Li^+ ion.

508 Unlike liquid-phase sintering, densification in these systems is primarily driven by atomic
509 diffusion. The small ionic radius (0.76 \AA for CN=6) and low charge (+1) of the Li^+ ion facilitate
510 a remarkably high diffusion coefficient, even at moderate temperatures [97]. This high mobility
511 allows lithium ions to act as an "internal fluxing agent," effectively lowering the activation
512 energy for the rate-limiting mass transport mechanisms, such as grain boundary and volume
513 diffusion. In essence, the mobile Li^+ ions promote the necessary atomic rearrangement for neck
514 growth and pore elimination without requiring the formation of a pervasive liquid phase. This
515 localized "weakening" or increased dynamism in specific bond environments contributes to
516 easier bond breaking and reforming, reducing the overall thermal energy required for sintering.

517 This is why lithium-based compounds with structures like rock salt (*e.g.*, Li_2TiO_3 , $\text{Li}_3\text{Mg}_2\text{NbO}_6$)
518 and spinel (*e.g.*, $\text{Li}_3\text{Mg}_4\text{NbO}_8$) have emerged as promising materials for high-performance
519 microwave applications, often achieving high $Q \times f$ values ($>50,000$ GHz) at sintering
520 temperatures below 950°C [37, 98-100].

521 The presence of mobile Li ions contributes to densification at lower temperatures. According
522 to the relationship between cohesive energy and melting point proposed by Van Uitert [97],
523 materials with lower packing fractions (typically $<60\%$) tend to have lower sintering
524 temperatures. However, exceptions exist: Li_3NbO_4 exhibits a packing fraction $>65\%$ but can be
525 sintered below 950°C due to its weak Li–O bonds and high bond polarity, which reduce the
526 activation energy for solid-state diffusion [29]. This is consistent with the Shannon's ionic radius
527 rules [101] and has been experimentally confirmed by Zhou *et al.* [97] Another striking exception
528 is Li_2WO_4 , which adopts a phenacite-type structure (space group $I4_1/amd$). Despite its relatively
529 high packing fraction arising from a dense framework of WO_6 octahedra, Li_2WO_4 can be
530 densified at only $640\text{--}660^\circ\text{C}$ with a remarkable $Q \times f$ value of $\sim 62,000$ GHz, as reported by Zhou
531 *et al.* [27]. Its ultra-low sintering temperature is attributed to the weak Li–O bonding and the high
532 polarizability of the phenacite structure, which facilitates Li^+ diffusion even at moderate
533 temperatures. Moreover, Li_2WO_4 exhibits excellent chemical compatibility with both Ag and Al
534 electrodes at its sintering temperature, making it a promising ULTCC candidate for millimeter-
535 wave and terahertz applications [27, 102].

536 Recent investigations have revealed that partial substitution of O^{2-} anions with F^- anions can
537 significantly reduce the sintering temperature of rock salt-structured materials. This strategy
538 operates on a fundamental crystal chemistry principle: the substitution of a divalent O^{2-} anion
539 with a monovalent F^- anion introduces charge-compensating vacancies (either cation or anion

540 vacancies, depending on the system) and locally alters the Madelung energy of the lattice. This
541 disruption can weaken the overall cohesive energy of the crystal, effectively lowering its melting
542 point and, consequently, the sintering temperature. Moreover, the presence of fluorides can lead
543 to the formation of low-melting eutectic phases with the oxide matrix, introducing a localized
544 liquid phase at lower temperatures that further enhances densification kinetics. This dual
545 mechanism is evident in the properties of several low-temperature sintered fluorides. For
546 example, LiF exhibits a very negative τ_f microwave dielectric ceramic with high $Q \times f$ of 73,800
547 GHz, $\epsilon_r=9$ and $\tau_f=-118$ ppm/ $^{\circ}$ C when sintered at 800 $^{\circ}$ C [103]. Although LiF itself has good
548 microwave dielectric properties, it can be used as a dopant for properties tuning. Yang *et al.*
549 incorporated LiF into $\text{Zn}_{1.8}\text{SiO}_{3.8}$ ceramics. Just 2 wt% of LiF was required to form a sufficient
550 liquid phase capable of filling the pores to improve relative density and no secondary phases
551 were detected in the XRD patterns. However, due to the volatilization of Li during sintering,
552 ceramics with higher LiF content did not achieve further densification. The microwave dielectric
553 properties were reported to be $\epsilon_r=6.3$, $Q \times f=64,200$ GHz, and $\tau_f=-21.1$ ppm/ $^{\circ}$ C with the sintering
554 temperature decreased from 1325 $^{\circ}$ C to 950 $^{\circ}$ C [104]. Zhang *et al.* reported a significant reduction
555 in the sintering temperature of $\text{Li}_2\text{Mg}_3\text{TiO}_6$ from 1280 $^{\circ}$ C to 950 $^{\circ}$ C through the partial substitution
556 of 8% O^{2-} with F^- [105]. $\text{Li}_4\text{NbO}_4\text{F}$ ceramics can be sintered at low temperatures (750 $^{\circ}$ C–875
557 $^{\circ}$ C) to achieve high $Q \times f$ values up to 61,111 GHz and τ_f of -51 ppm/ $^{\circ}$ C [106], $\text{Li}_7\text{Ti}_3\text{O}_9\text{F}$ at 950
558 $^{\circ}$ C, having $Q \times f=88,200$ GHz, $\epsilon_r=22.5$, and $\tau_f=-24.2$ ppm/ $^{\circ}$ C [107].

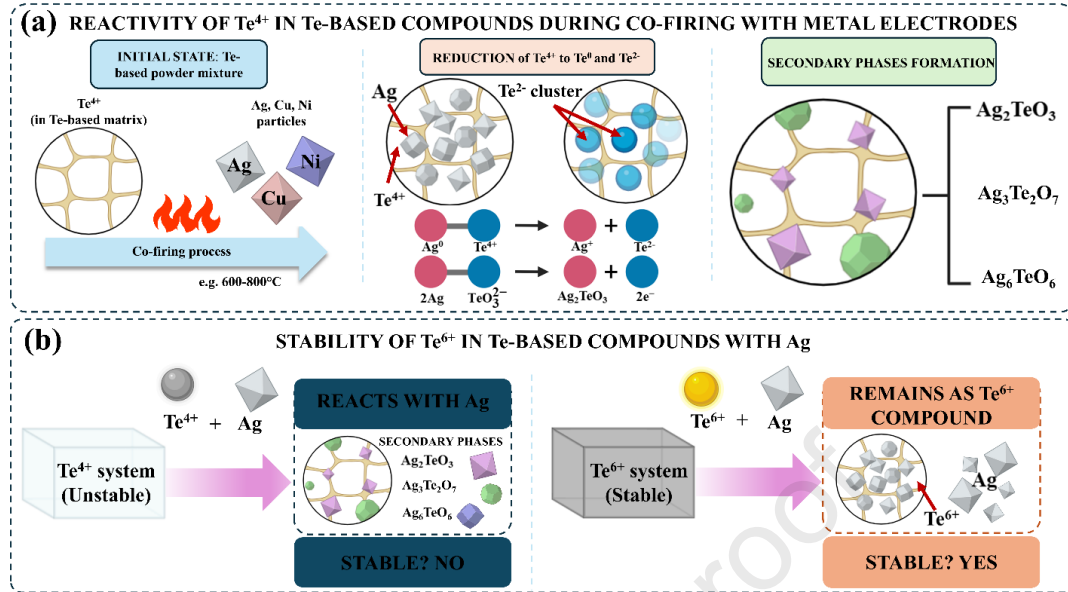
559 Apart from the rock-salt structure, spinel structure $\text{Li}_2\text{MTi}_3\text{O}_8$ (M=Zn, Mg, Co, Cu, etc.) has
560 been paid attention since 2010. Microwave dielectric features of $\text{Li}_2\text{ZnTi}_3\text{O}_8$ ceramic with cubic
561 structure were firstly investigated by the research group of Zhou [30]. It was reported that there is
562 some relevance between the degree of ordering and the microwave dielectric properties of

563 $\text{Li}_2\text{ZnTi}_3\text{O}_8$ ceramic. This compound is normally sintered at temperature around 1050°C - 1125°C
564 using traditional sintering ($Q \times f = 62,000$ GHz, $\epsilon_r = 26.2$, and $\tau_f = -15$ ppm/ $^\circ\text{C}$) [30]. For the
565 occupation of Mg at M-site, the sintering temperature of $\text{Li}_2\text{MgTi}_3\text{O}_8$ shows similar to those used
566 for the $\text{Li}_2\text{ZnTi}_3\text{O}_8$ system which is 1075°C [108]. However, the sintering temperatures required
567 to densify the material are typically too high for co-firing with metal electrodes. It has been
568 reported that substituting ions at the M-site with ions of similar ionic radii can effectively reduce
569 the sintering temperature while also improving the microwave dielectric properties [109-111].
570 This strategy has been significantly enhanced by first-principles calculations based on Density
571 Functional Theory (DFT), which can predict the energetic favorability of specific substitutions
572 and their resulting effect on the lattice dynamics and dielectric properties. Such computational
573 screening allows for a more targeted and efficient approach to material design, moving beyond
574 simple ionic radii rules to a more fundamental understanding of structure-property relationships.
575 The difference between the substituted cations and the host cations should be less than 10% to
576 induce the ordering effect in the system [101, 112].

577 **4.2.2 Tellurate-Based Systems**

578 Tellurate-based ceramics, such as BaTe_4O_9 , $\text{Bi}_2\text{Te}_2\text{O}_8$, and $\text{Zn}_2\text{Te}_3\text{O}_8$, MgTeMoO_6 ,
579 ZnTeMoO_6 , $\text{Li}_3\text{Y}_3\text{Te}_2\text{O}_{12}$ and $\text{Li}_3\text{Yb}_3\text{Te}_2\text{O}_{12}$, present good microwave dielectric feature with low
580 sintering temperature [113-117]. Tellurate-based compounds are particularly interesting because
581 tellurium can adopt two distinct oxidation states: Te^{4+} and Te^{6+} . It is noted that Te^{4+} is prone to
582 reaction with silver metal.

583



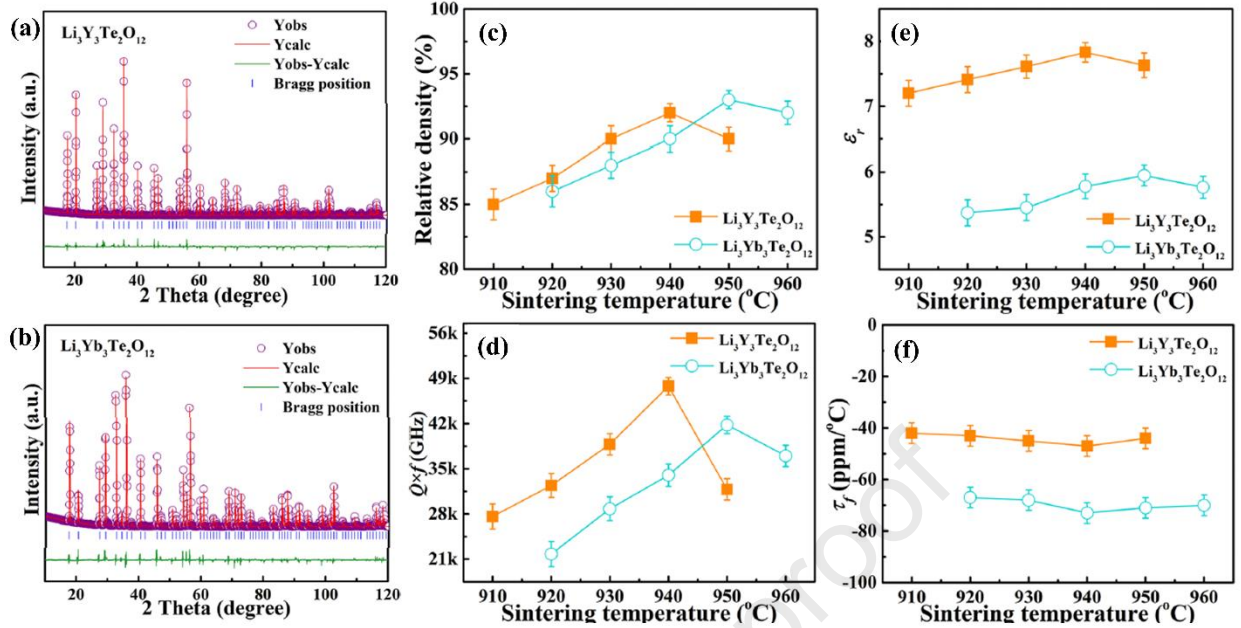
584

585 **Fig. 8** A schematic diagram illustrating the redox reaction between tellurate-based ceramics
 586 containing Te^{4+} ions and metal electrodes (e.g., Ag, Cu). (a) At elevated co-firing temperatures,
 587 the Te^{4+} ions are reduced to elemental tellurium (Te^0 , Te^{2-}), which subsequently reacts with the
 588 metal electrode to form undesirable secondary phases such as Ag_2Te and other tellurides,
 589 compromising the device performance. (b) Comparison of the stability of Te^{6+} and Te^{4+} during
 590 co-firing with Ag.

591 Te^{4+} ions are susceptible to redox reactions at elevated temperatures, especially during co-
 592 firing with metal electrodes such as Ag, Cu, or Ni (see Fig. 8). The Te^{4+} species can be reduced to
 593 Te^0 (elemental Te) or even further to Te^{2-} [118]. This reaction leads to the undesirable formation
 594 of secondary phases like Ag_6TeO_6 , Ag_2TeO_3 , and $\text{Ag}_3\text{Te}_2\text{O}_7$ [119]. In contrast, Te^{6+} is considerably
 595 more stable and shows no reactivity with silver. The rational design of novel Te^{6+} -based
 596 compounds with low sintering temperatures is an active area of research, increasingly guided by
 597 high-throughput computational screening. By combining DFT calculations with crystal structure
 598 prediction algorithms, researchers are systematically exploring the vast compositional space to
 599 identify new, thermodynamically stable Te^{6+} garnets and perovskites that are predicted to exhibit

600 excellent microwave dielectric properties and chemical compatibility with silver, paving the way
601 for the next generation of tellurate-based LTCCs. For example, recent studies have used DFT to
602 compute the electronic structure, lattice dynamics, and phonon behavior of garnet-type tellurates
603 such as $\text{Li}_3\text{Y}_3\text{Te}_2\text{O}_{12}$ and $\text{Li}_3\text{Yb}_3\text{Te}_2\text{O}_{12}$ [117, 120]. By calculating key properties such as band
604 gap, dielectric permittivity, and phonon dispersion, DFT enables rapid prescreening of candidate
605 compositions before experimental synthesis. This computational pre-selection drastically reduces
606 the number of experimental iterations required to achieve a target microwave performance.
607 Furthermore, machine learning models employing physically meaningful descriptors, notably
608 bond ionicity, packing fraction, and cation polarizability, have been trained on existing tellurate
609 and perovskite databases [121]. These models can rapidly screen thousands of hypothetical
610 compositions and predict key microwave properties such as $Q \times f$ and ϵ_r . The synergy of
611 DFT-calculated ground-state properties and ML-driven high-throughput screening is now being
612 applied to identify new tellurate variants with predicted $Q \times f$ exceeding 150,000 GHz and
613 sintering temperatures below 700 °C, thereby accelerating the development of next-generation
614 ULTCC materials.

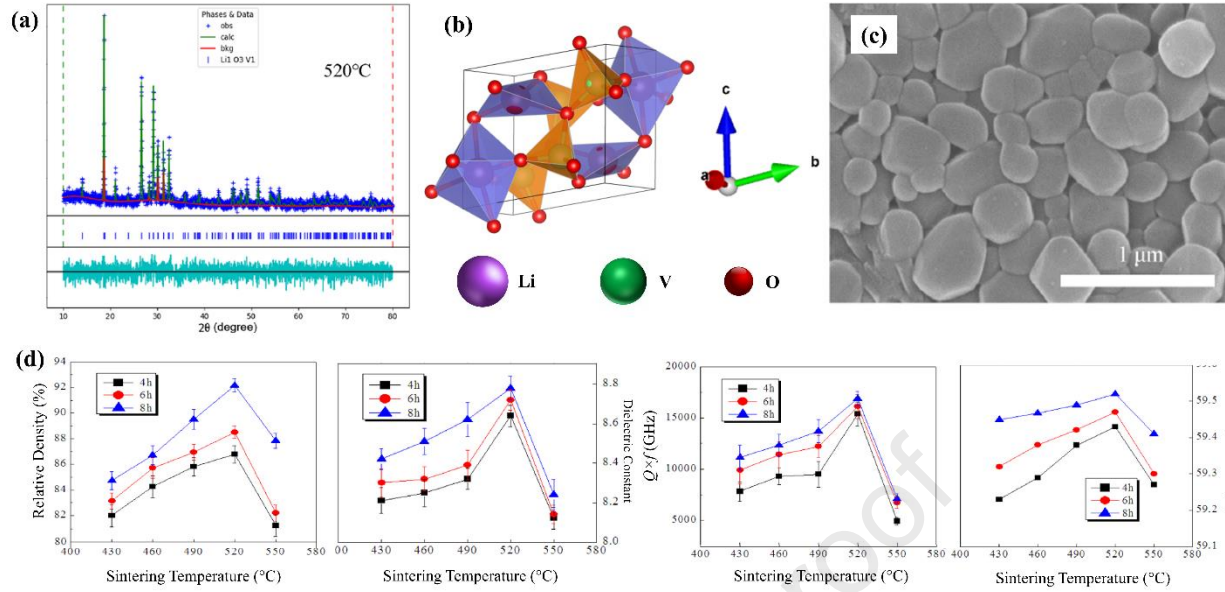
615 For the Te^{6+} compounds (see Fig. 9), Y. Tang *et al.* simply prepared the compounds via
616 conventional sintering. The resulting $\text{Li}_3\text{Y}_3\text{Te}_2\text{O}_{12}$ displayed good microwave dielectric properties
617 after sintered at 940 °C ($\epsilon_r=7.83 \pm 0.2$, $Q \times f=47,800 \pm 500$ GHz and $\tau_f=-47 \pm 3.0$ ppm/°C), while
618 $\text{Li}_3\text{Yb}_3\text{Te}_2\text{O}_{12}$ ceramic shows the best microwave dielectric properties after sintered at 950 °C
619 ($\epsilon_r=5.94 \pm 0.2$, $Q \times f=41,800 \pm 500$ GHz and $\tau_f=-76 \pm 3.0$ ppm/°C). These compounds also show
620 good compatibility with silver which makes them a good candidate for LTCC technology.



621
 622 **Fig. 9** (a-b) XRD patterns of $\text{Li}_3\text{Yb}_3\text{Te}_2\text{O}_{12}$ and $\text{Li}_3\text{Y}_3\text{Te}_2\text{O}_{12}$ ceramics, respectively. (c-f) Relative
 623 density and microwave dielectric of $\text{Li}_3\text{Yb}_3\text{Te}_2\text{O}_{12}$ and $\text{Li}_3\text{Y}_3\text{Te}_2\text{O}_{12}$ ceramics as a function of
 624 sintering temperature [117].

625 4.2.3 Vanadate and Silicate Systems

626 A wide range of V_2O_5 -based microwave dielectric compounds has been extensively
 627 investigated and reported, owing to their low synthesis temperatures and superior chemical
 628 compatibility with Ag electrodes [122-124]. LiVO_3 is one of the vanadate-based compounds that
 629 show very low sintering temperature. C. Yin *et al.* demonstrated the microwave dielectric
 630 properties of LiVO_3 ceramics. It shows a pure monoclinic single phase with a $C2/c$ space group.
 631 Optimal sintering conditions of 520°C for 8 hours yielded excellent microwave dielectric
 632 properties ($\epsilon_r=8.78$, $Q \times f=16,900$ GHz and $\tau_f=-117$ ppm/ $^\circ\text{C}$) (see Fig. 10) [125].



633

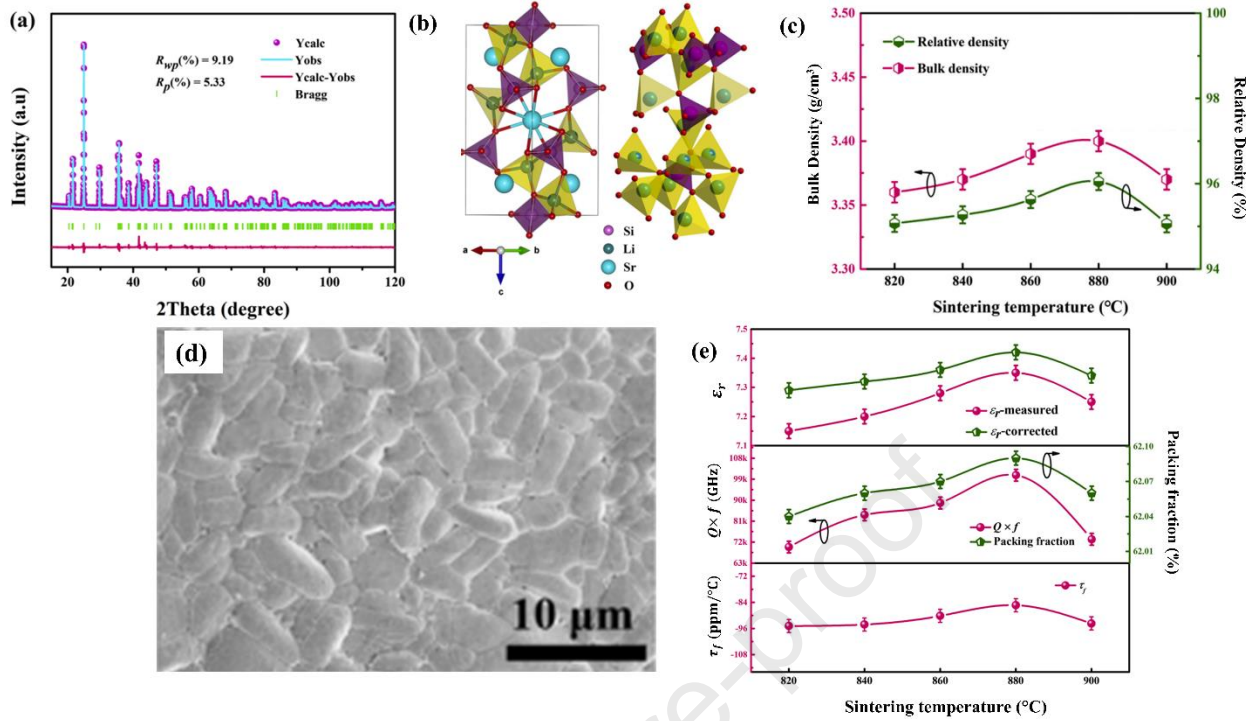
634 **Fig. 10** LiVO_3 ceramics prepared by conventional sintering. (a,b) XRD pattern and microstructure
 635 of ceramic sintered at 520°C for 8 h. (c) Density and microwave dielectric properties as a
 636 function of sintering temperature [125].

637 Silicate-based olivine crystal structure was reported as another interesting LTCC system. It
 638 possesses a relatively high covalent bonding which is known as high sintering temperature
 639 microwave dielectric system ($T_s \sim 1300\text{--}1500^\circ\text{C}$). The high bond strength of the SiO_4 tetrahedral
 640 leads to low permittivity and high $Q \times f$. Substitution of Li^+ onto the A-site of the olivine structure
 641 can reduce the sintering temperature by $200\text{--}500^\circ\text{C}$. $\text{Li}_2\text{SrSiO}_4$, when sintered at 880°C , it
 642 exhibited microwave dielectric properties of $\epsilon_r = 7.4$, $Q \times f = 100,700 \text{ GHz}$, and $\tau_f = -85.4 \text{ ppm}/^\circ\text{C}$
 643 (Fig. 11) [126].

644 Li-containing compounds are one of the keys for LTCC. However, there are some factors that
 645 might be determined. The presence of lithium and the resulting sintering mechanisms can have
 646 complex effects on the microwave dielectric properties. If the Li-containing liquid phase does not
 647 fully crystallize or is not completely incorporated into the main ceramic grains, a residual glassy
 648 phase at grain boundaries can act as a significant source of dielectric loss, especially if it contains

649 mobile Li^+ ions. Mobile ions contribute to relaxation losses at microwave frequencies,
650 substantially lowering the $Q \times f$. Uncontrolled reactions leading to highly lossy secondary phases
651 can also occur. Conversely, if the liquid phase perfectly aids densification by eliminating porosity
652 (a major source of extrinsic loss) and facilitates the formation of a highly ordered, defect-free
653 main phase, the $Q \times f$ can be optimized. Some Li-containing compounds are also intrinsically low-
654 loss.

655 Moreover, the τ_f is a composite property affected by the thermal expansion and temperature
656 dependence of the permittivity of all phases present. The thermal expansion and dielectric
657 temperature characteristics of the Li-containing glassy or crystalline phases can significantly shift
658 the τ_f of the composite, requiring careful tuning to achieve a near-zero value for temperature-
659 stable devices. Optimizing these systems requires a delicate balance: maximizing densification
660 and Ag-compatibility while simultaneously ensuring that the inherent advantages of low-
661 temperature processing do not compromise the critical microwave dielectric properties,
662 particularly the indispensable high $Q \times f$.



663

664 **Fig. 11** (a) XRD pattern of $\text{Li}_2\text{SrSiO}_4$ ceramic sintered at 880°C , (b) crystal structure of $\text{Li}_2\text{SrSiO}_4$
 665 ceramic, (c) density of $\text{Li}_2\text{SrSiO}_4$ as a function of sintering temperature, (d) microstructure of
 666 $\text{Li}_2\text{SrSiO}_4$ ceramic, and (e) microwave dielectric properties as a function of sintering temperature
 667 [126].

668 **Table 2** Microwave dielectric properties and sintering temperature low-temperature firing
 669 compounds

Family	Compound	T_s ($^\circ\text{C}$)	ϵ_r	$Q \times f$ (GHz)	τ_f (ppm/ $^\circ\text{C}$)	Limitations	Ref.		
Li-rock salt	Li_2TiO_3 ,	900–1000	20–30	Medium-	Positive	Requires dopants for $Q \times f$	[127,		
	Li_2ZrO_3							high	(large)
Li-spinel	$\text{Li}_2\text{MgTi}_3\text{O}_8$,	800–900	13–16	High	Near zero	Li volatilization,	[30],		
	$\text{Li}_4\text{Mg}_3\text{Ti}_5\text{O}_{18}$							atmosphere sensitivity	[108]
Tellurate	BaTe_4O_9 ,	650–750	15–20	High	\pm tunable	Toxicity of Te, high raw	[113-		
	$\text{Bi}_2\text{Te}_2\text{O}_8$,							material cost	117]
	$\text{Zn}_2\text{Te}_3\text{O}_8$,								

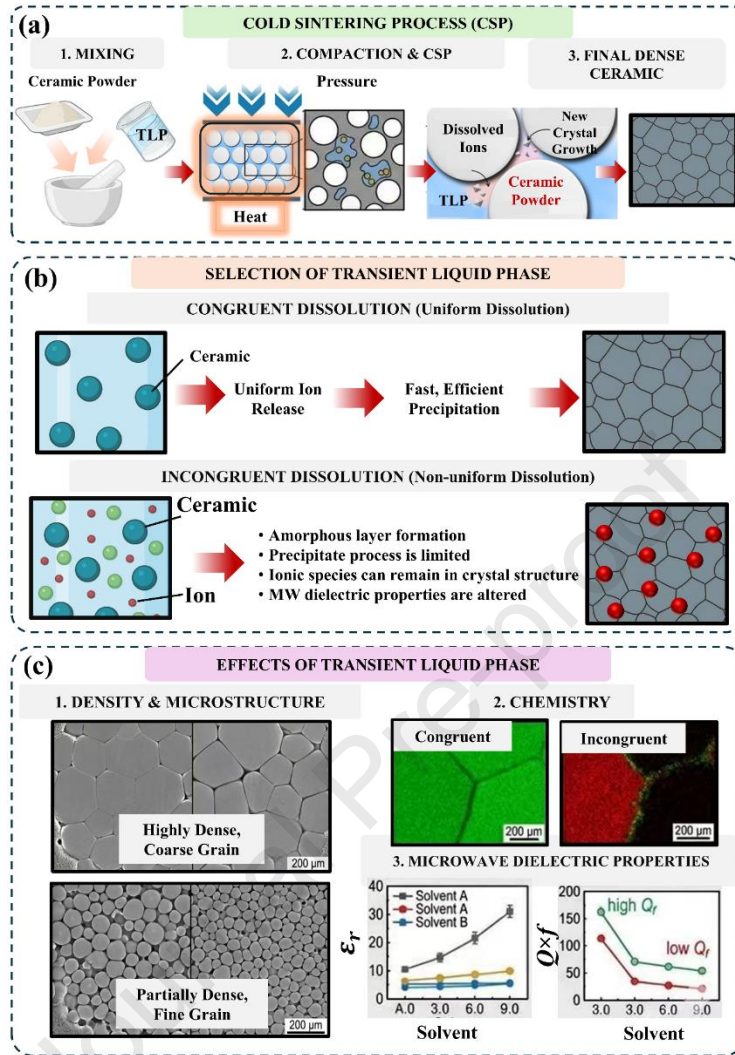
	MgTeMoO ₆ , ZnTeMoO ₆ , Li ₃ Y ₃ Te ₂ O ₁₂ Li ₃ Yb ₃ Te ₂ O ₁₂						
Vanadate	Ba ₃ (VO ₄) ₂ , Mg ₃ VO ₄) ₂ LiVO ₃	650–800	9–12	Medium- high	Negative	V ₂ O ₅ volatilization, atmosphere control needed	[125, 129]
Tungstate	MgWO ₄ , ZnWO ₄ , NiWO ₄ , CoWO ₄	850–950	15–18	Medium- high	Near zero	Higher T _s than vanadate/tellurate	[130]
Molybdate	ZnMoO ₄ , MgMoO ₄	800–900	12–15	Medium	Positive	Moderate Q×f, MoO ₃ volatility	[131, 132]
Borate-based ceramics	Zn ₃ B ₂ O ₆ , Mg ₃ B ₂ O ₆	750–850	7–10	Medium	Positive	Lower Q×f than oxide ceramics	[133, 134]

670

671 **4.3 Cold sintering process (CSP)**

672 As introduced historically in Section 3.5, CSP represents a paradigm shift in ceramic
673 processing by enabling densification at remarkably low temperatures. This section provides a
674 detailed mechanistic analysis of CSP, including the roles of the transient liquid phase,
675 dissolution-precipitation, congruent/incongruent behavior, post-annealing strategies, and the
676 critical issue of residual hydroxyl groups that affect microwave dielectric performance. Ceramic
677 materials are known for their high melting temperatures due to strong ionic and/or covalent
678 bonding. This necessitates high firing temperatures (typically exceeding 1,000 °C for oxides) and
679 long dwell times (several hours) to achieve dense samples. However, most ceramics are
680 fabricated by sintering powders at temperatures between 50% and 75% of their melting point.
681 While this approach can achieve theoretical densities exceeding 95%, it also makes the sintering

682 process energy intensive. An additional challenge arises when ceramics contain volatile elements
683 like Pb, Bi, Na, K, and Li. During high-temperature firing, these elements can evaporate, leading
684 to stoichiometric variations in the final material [135-139]. To maintain the desired composition,
685 various techniques are applied during the preparation process. For example, excess lead oxide is
686 added to lead-based systems to achieve the desired composition and high-density samples [140,
687 141]. Researchers have employed several techniques to reduce sintering temperature and time
688 consumption, including flash sintering [142], two-step sintering [143], spark plasma sintering
689 [144], and microwave-assisted sintering [145]. All the mentioned sintering methods involve a
690 diffusive mass transfer process to densify the ceramic samples. Sintering is driven by the
691 thermodynamic principle of minimizing surface energy. As temperature increases, atoms diffuse
692 and migrate to reduce surface area. This can cause the forming of necks between particles. This
693 densification process reduces porosity and can lead to grain growth. The ultra-low sintering
694 technique known as "cold sintering" was proposed by a research group of C. Randall. This term
695 serves to distinguish it from traditional sintering methods, which necessitate high
696 temperatures.[16]. The technique is a low-temperature consolidation method (temperature below
697 400 °C) used to fabricate materials and their composites by applying transient solvents with the
698 assistance of external pressure which is much lower than the traditional high-temperature sintering
699 process (temperature >1000 °C) [64]. The densification of ceramics by this technique is achieved
700 through a dissolution-precipitation mechanism which depends on several factors, such as solvent
701 type, applied pressure, temperature, and processing time [146-148]. The schematic diagram of
702 cold sintering process is shown in Fig. 12.



703

704 **Fig. 12** (a) Schematic of CSP mechanism, from powder–solvent mixture to densified ceramic. (b)

705 Diagram highlighting the transient liquid phase selection, distinguishing congruent from

706 incongruent dissolution. (c) Role of the transient liquid phase in promoting densification versus

707 incongruent dissolution, which may introduce defects and affect microwave dielectric properties.

708 Cold sintering technique is very similar to liquid-phase sintering [149]. In conventional

709 liquid-phase sintering, the glass phase is melted at high temperatures. In contrast, ceramic

710 densification is achieved by adding solvents and applying high pressure for cold sintering. The

711 steps of densification can be divided into two main steps. At the first step, it involves particle

712 rearrangement and compaction under external pressure and capillary forces. The presence of a
713 transient solution, elevated temperature, and increased pressure accelerates this process compared
714 to traditional dry pressing. The second stage of sintering involves densification through the filling
715 of voids between grains. In conventional solid-state sintering, mass transport occurs
716 predominantly through solid-state diffusion mechanisms. However, in cold sintering, the lower
717 temperature regime favors dissolution-precipitation as the dominant mass transport mechanism.
718 Dissolution-precipitation is particularly effective for compositionally sensitive ceramics that
719 exhibit congruent dissolution. For systems with limited solubility or incongruent dissolution,
720 densification may still occur, but this can compromise the overall material properties. A
721 representative case is BaTiO_3 , a prototypical ferroelectric material that exhibits strongly
722 incongruent dissolution in pure water. During conventional cold sintering with water as the
723 transient liquid, Ba^{2+} ions preferentially leach out, leaving behind an amorphous Ti-rich layer that
724 hinders reprecipitation and results in poor densification ($\sim 70\%$ relative density) [57]. To
725 overcome this limitation, barium hydroxide octahydrate ($\text{Ba}(\text{OH})_2 \cdot 8\text{H}_2\text{O}$) has been employed as
726 a hydrated flux [150-152]. The excess Ba^{2+} ions in the transient liquid phase shift the local
727 chemical equilibrium, suppress Ba leaching, and promote a more congruent-like dissolution–
728 precipitation pathway. Consequently, a relative density of $\sim 95\%$ and a permittivity exceeding
729 1000 can be achieved at only $150\text{ }^\circ\text{C}$ [151]. Nevertheless, this system is not fully congruent; high
730 uniaxial pressure (350 MPa) or subsequent post-annealing ($600\text{ }^\circ\text{C}$) remains necessary to attain
731 optimal microwave dielectric properties, highlighting the remaining kinetic barriers [16]. Some
732 representative examples of solubility behavior and its impact on densification and phase purity in
733 CSP are summarized in Table 3.

734 **Table 3** Solubility behavior and its impact on the cold sintering process (CSP).

Ceramic system	Transient liquid phase	Dissolution behavior	Key Observations	Ref.
Li₂MoO₄	Deionized H ₂ O	Congruent	Complete dissolution and reprecipitation; no secondary phases	[153, 154]
Na₂Mo₂O₇	Deionized H ₂ O	Congruent	Full solubility in water; rapid densification	[56, 155]
K₂MoO₄	Deionized H ₂ O	Congruent	Similar to Li/Na molybdates	[156]
LiMgPO₄	Deionized H ₂ O	Congruent (Limited solubility)	Moderate solubility; assisted by pressure	[157]
BaTiO₃	Deionized H ₂ O	Incongruent	Ba ²⁺ leaches out, forms amorphous Ti-rich layer on particle surfaces	[57]
BaTiO₃	Ba(OH) ₂ /TiO ₂ Suspension	Congruent	Solvent chemistry adjusted to match Ba/Ti stoichiometry	[150-152]
Mg₃B₂O₆	Acetic acid (13.5M)	Congruent	Acid enhances solubility; prevents hydrolysis	[158]
ZnO	Acetic acid (0.5-5M)	Congruent	Acid increases Zn ²⁺ solubility; promotes dissolution-precipitation	[146, 149]
ZnO	Deionized H ₂ O	Incongruent	Very low solubility in water	[159]

735

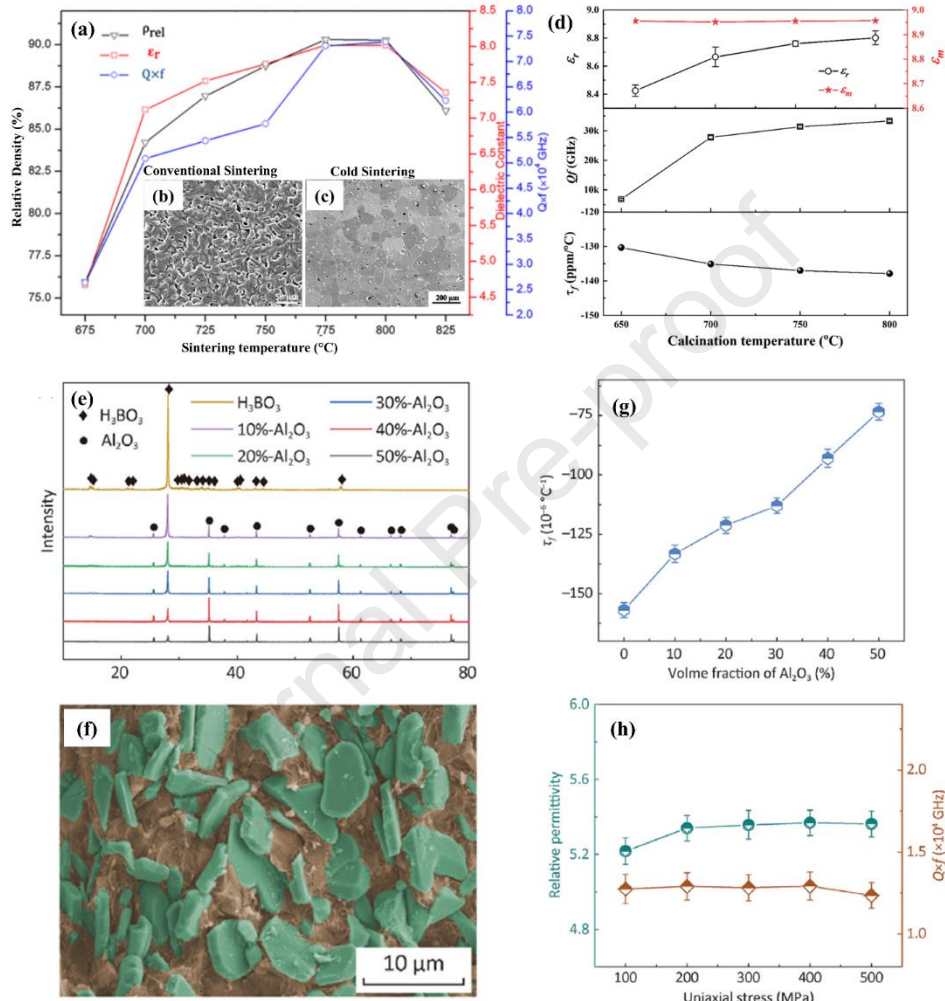
736 For microwave dielectric compounds, the cold sintering technique is proposed to fabricate in
737 both single phase and composite microwave dielectrics. For the single-phase microwave
738 dielectric, molybdate families have been fabricated using deionized water. Li₂MoO₄ which
739 dissolves in deionized water can be densified at room temperature under a pressure of 130 MPa
740 ($\rho=87\%-93\%$, $\epsilon_r=4.6-5.2$ and $Q \times f=10,200-18,500$ GHz) [160]. Other compounds that can be
741 densified using deionized water are, for examples, Na₂Mo₂O₇ ($\rho=93.7\%$, $\epsilon_r=13.4$, $Q \times f=14,900$
742 GHz), K₂Mo₂O₇ ($\rho=94.1\%$, $\epsilon_r=9.8$, $Q \times f=16,000$ GHz) [56], (Li,Bi)_{0.5}MoO₄ ($\rho=88.5\%$, $\epsilon_r=33.7$,

743 $Q \times f = 2,300$ GHz, $\tau_f = +184$ ppm/ $^{\circ}$ C), $\text{Na}_{0.5}\text{Bi}_{0.5}\text{MoO}_4$ ($\rho = 85\%$, $\epsilon_r = 20.7$, $Q \times f = 1,500$ GHz, $\tau_f = +46$
 744 ppm/ $^{\circ}$ C) [154], $(\text{Bi}_{0.95}\text{Li}_{0.05})(\text{V}_{0.9}\text{Mo}_{0.1})\text{O}_4$ ($\rho = 73\%$, $\epsilon_r = 30$, $Q \times f \sim 1300$ GHz, $\tau_f = +61$ ppm/ $^{\circ}$ C),
 745 K_2MoO_4 ($\rho = 100\%$, $\epsilon_r = 6.37$, $Q \times f = 26,500$ GHz, $\tau_f = -70$ ppm/ $^{\circ}$ C), NaBiSrMoO_4 ($\rho = 94\%$,
 746 $\epsilon_r = 15.48$, $Q \times f = 18,763$ GHz, $\tau_f = +2.7$ ppm/ $^{\circ}$ C) [156], LiMgPO_4 ($\rho = 93\%$, $\epsilon_r = 6.5$, $Q \times f = 16,000$
 747 GHz) [157]. As seen, the microwave dielectric compounds that can be cold sintered are mostly
 748 contained molybdenum. However, the high cost of molybdenum can limit the economic benefits
 749 of cold sintering.

750 Zhou *et al.* demonstrated the cold sintering technique for LiF microwave dielectric ceramics
 751 using water as the transient liquid phase [161]. The compound normally exhibits a low firing
 752 temperature ($T_s \sim 800^{\circ}\text{C}$). The previously reported the relative density of the conventional
 753 sintered LiF is 90.2% with $Q \times f$ value of 73,800 GHz (see Fig. 13 (a-d)) [103]. However, the cold
 754 sintered LiF shows the higher relative density around 97%. In that work, optimal microwave
 755 dielectric properties were achieved when samples were sintered under a pressure of 600 MPa at
 756 100°C , yielding $\epsilon_r = 8.56$, $Q \times f = 143,000$ GHz, and $\tau_f = -137$ ppm/ $^{\circ}\text{C}$ [161]. In a separate study,
 757 LiF ceramics were also prepared using the cold sintering technique, but notably, with an initial
 758 pre-calcination step. Yuan *et al.* reported that the pre-calcination temperature significantly
 759 influenced the microstructure and microwave dielectric properties of the final product. The higher
 760 $Q \times f$ value could be primarily attributed to improvements in both density and crystallinity.
 761 Optimal microwave dielectric properties ($\epsilon_r = 8.80$, $Q \times f = 33300$ GHz, and $\tau_f = +138$ ppm/ $^{\circ}\text{C}$) were
 762 attained by cold sintering LiF powder that was pre-calcined at 800°C [162].

763 While these CSP-processed LiF systems already demonstrate impressive $Q \times f$ values
 764 compared to many other low-temperature ceramics, when benchmarked against projected
 765 sub-THz 6G requirements ($Q \times f > \sim 200,000$ GHz and $\tan \delta$ in the 10^{-5} – 10^{-6} range), it is clear that

766 CSP-based materials still face a substantial performance gap. This gap motivates the hybrid CSP
 767 + post-annealing strategies and solvent-engineering approaches discussed in the following
 768 sections.



769

770 **Fig. 13** LiF ceramics prepared by conventional sintering and cold sintering techniques. (a)
 771 Relative density and microwave dielectric properties as a function of sintering temperature. (b)
 772 Microstructure of conventional sintered LiF ceramics. (c) microstructure of cold sintered LiF
 773 ceramics. (d) Microwave dielectric properties as a function of calcination temperature. Adapted
 774 from Ref. [103, 162]. Characterization of cold sintered Al₂O₃- H₃BO₃ composite ceramics. (e)
 775 XRD patterns showing the phase composition as a function of Al₂O₃ volume fraction. (f)

776 Scanning electron microscope (SEM) micrograph of the composite with 50 vol% Al₂O₃, showing
777 plate-like Al₂O₃ particles (false-colored green) embedded in the H₃BO₃ matrix. (g) Temperature
778 coefficient of resonant frequency (τ_f) as a function of Al₂O₃ volume fraction. (h) Relative
779 permittivity (ϵ_r) and quality factor ($Q \times f$) as a function of applied uniaxial stress for the 50 vol%
780 Al₂O₃ composite. Adapted from Ref. [163].

781 Zeng *et al.* reported the room temperature sintering of Al₂O₃-H₃BO₃ composite ceramic
782 which exhibits negative τ_f . They found that H₃BO₃ facilitates plastic deformation in a deionized
783 water medium, which significantly enhances the densification of Al₂O₃-H₃BO₃ ceramics even
784 under minimal uniaxial stress (100 MPa). The resulting material achieves a high relative density
785 exceeding 96% with good microwave dielectric properties ($\epsilon_r=5.37$, $Q \times f=12,924$ GHz, and
786 $\tau_f=-73.42$ ppm/°C) (see Fig. 13 (e-h)) [163].

787 Researchers are exploring alternative materials such as aluminates, titanates, and phosphates.
788 While these materials may have lower solubility, making cold sintering more challenging, they
789 offer potential for lower-cost, high-performance microwave ceramics. It is important to note that
790 while cold sintering can produce fine-grained ceramics, the specific grain size and microstructure
791 can be influenced by factors such as the starting powder size, solvent type, applied pressure, and
792 sintering temperature.

793 In some cases, cold sintering technique is employed to fabricate ceramic compounds that
794 exhibit limitations when processed through conventional sintering. M. Chi *et al.* prepare
795 Mg₃B₂O₆ ceramic by cold sintering at 150 °C using acetic acid as a transient liquid phase
796 followed by post annealing. This ceramic system showed some evaporation and decomposition
797 during the conventional sintering at sintering temperature around 1300°C [134, 164]. Ceramic
798 obtained by cold sintering technique showed the relative density around 80%. After post

799 annealing at 900 °C, the density improved to 91% with good microwave dielectric properties
800 ($\epsilon_r=6.37$, $Q \times f=16,686$ GHz, and $\tau_f=-63.74$ ppm/°C) [158].

801 Although the cold sintering process provides a promising paradigm of low temperature
802 ceramic processing, its utility for ultra-high Q microwave dielectrics is fundamentally limited by
803 materials science constraints that are inherent to its low-temperature, solution-based mechanism.
804 The low temperature densification mechanism in cold sintering is insufficient to overcome the
805 kinetic limitations for pore elimination and, more critically, for the formation of chemically and
806 structurally pristine grain boundaries. Moreover, inhomogeneity, residual elements from transient
807 liquid phase and microstructural defects are factors that make cold sintering a challenging
808 technique for microwave dielectric ceramics fabrication. Conventional sintering achieves
809 densification predominantly through solid-state diffusion kinetics using high thermal energies.
810 This elevated temperature promotes rapid atomic and vacancies mobility where pore can be
811 eliminated easily. In contrast, the densification process in cold sintering is different. At low
812 temperatures, the rate of atomic diffusion in the solid state is extremely low. Thus, the kinetics of
813 pore elimination in the final stage of sintering are restricted [57]. Incomplete removal of transient
814 liquid phase components or their decomposition products can leave behind nanoscale voids or
815 residues that contribute to porosity. However, for ultra-high Q materials, the most detrimental
816 factors extend beyond simple porosity and lie within the chemistry and structure of the grain
817 boundaries themselves.

818 Firstly, the incomplete removal of the aqueous transient phase, which is fundamental to the
819 CSP mechanism, often leaves residual hydroxyl groups (OH^-) trapped within the ceramic matrix.
820 These polar OH^- groups, particularly concentrated at the grain boundaries, possess a strong
821 dipole moment. When subjected to an oscillating microwave electric field, these dipoles attempt

822 to reorient, leading to significant dipolar relaxation losses which directly and severely degrade
 823 the quality factor. The low processing temperature of CSP is insufficient to drive off these
 824 chemically bound species, making this a fundamental challenge. For cold-sintered $\text{Mg}_3\text{B}_2\text{O}_6$ by
 825 Chi *et al.* [158], their work clearly shows a broad FTIR absorption band centered at $\sim 3400 \text{ cm}^{-1}$
 826 (characteristic of O-H stretching) in the as-cold sintered sample. This band virtually disappears
 827 after post-annealing at $900 \text{ }^\circ\text{C}$, 3h. Critically, the $Q \times f$ value increases from $\sim 5900 \text{ GHz}$ to ~ 16700
 828 GHz , directly linking the removal of OH^- to the suppression of dielectric loss. For LiF, we also
 829 include a similar correlation from Zhou *et al.* [161], where the $Q \times f$ value improves from ~ 4500
 830 GHz to $>111,000 \text{ GHz}$ after a $800 \text{ }^\circ\text{C}$ anneal, which is attributed to the elimination of residual
 831 OH^- and other point defects. These representative cases clearly demonstrate that post-annealing
 832 in the $400\text{-}800 \text{ }^\circ\text{C}$ range can yield a factor-of-two or greater improvement in $Q \times f$ via the removal
 833 of residual OH^- and the healing of grain-boundary defects, as summarized in Table 4. The Effect
 834 of post-annealing temperature on the microwave dielectric properties are summarized in Table 4.
 835 **Table 4** Effect of post-annealing temperature on the microwave dielectric properties of cold-
 836 sintered ceramics (comparison in the $400\text{-}800 \text{ }^\circ\text{C}$ range)

Ceramic system	CSP condition	Annealing condition	$Q \times f$ (GHz)		Key change	Ref.
			As-cold sintered	After annealing		
LiF	150 $^\circ\text{C}$, 250 MPa	800 $^\circ\text{C}$, 2 h	~ 4500	~ 111000	$Q \times f$ improves from ~ 4500 to $\sim 111000 \text{ GHz}$ due to OH^- elimination	[165]
$\text{Mg}_3\text{B}_2\text{O}_6$	150 $^\circ\text{C}$, 800 MPa	900 $^\circ\text{C}$, 3 h	~ 5900	~ 16700	As-cold sintered sample exhibits strong OH^- band (FTIR), post-annealing at $900 \text{ }^\circ\text{C}$ removes OH^-	[158]
$\text{Zn}_3\text{B}_2\text{O}_6$	200 $^\circ\text{C}$, 300 MPa	550 $^\circ\text{C}$, 3 h	~ 6300	21000	Acetic acid transient liquid leaves residual OH^- /acetate; annealing at $550 \text{ }^\circ\text{C}$ removes	[166]

these species. Post-annealing also promotes fine grain precipitation between larger grains, forming uniform dense microstructure

BaF₂	150 °C, 600 MPa	900 °C, 3 h	~53000 (conventional sintered)	~82000	No aqueous solvent used, post-annealing enhances crystallinity and density,	[167]
CaF₂	150 °C, 750 MPa	1,000 °C, 3 h	~26000 (conventional sintered)	~81000	OH ⁻ not relevant, post-annealing eliminates the amorphous grain-boundary phase, leading to clearer grain boundaries, higher crystallinity, and thus higher $Q \times f$.	[168]
TiO₂	300 °C, 350 MPa	1,000 °C, 2 h	~6000 (conventional sintered)	31900	CSP+ post-annealing promotes recrystallization with clear grain boundaries and reduced amorphous phase.	[169]

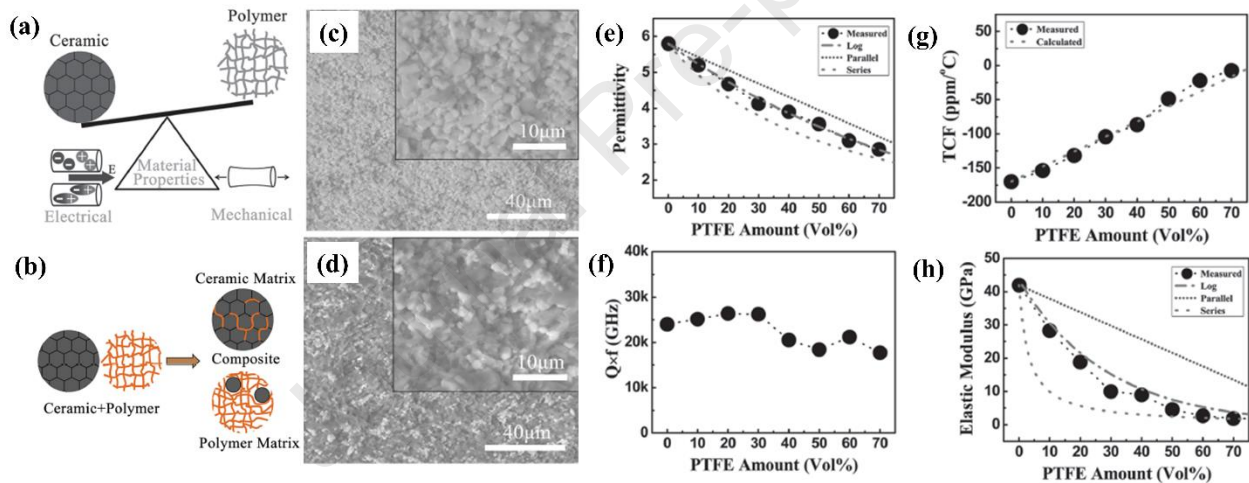
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838 Secondly, the dissolution-precipitation process can result in the formation of a thin, disordered
839 amorphous phase at the grain boundaries. Unlike the highly ordered, low-loss crystalline grains,
840 this amorphous interfacial layer disrupts long-range lattice periodicity, increases phonon
841 scattering, and introduces a continuum of energy states that dissipate microwave energy. This
842 structurally imperfect “glue” between grains acts as an intrinsically lossy medium, placing a
843 ceiling on the achievable $Q \times f$ value, regardless of the bulk crystal quality.

844 As known, the dielectric permittivity of air is around 1 ($\epsilon_r \sim 1$). The presence of such porosity,
845 along with these chemically and structurally defective grain boundaries, leads to a reduction in
846 the overall effective permittivity (ϵ_r) of the material and an increase in dielectric loss. Even a
847 small volume of pores, coupled with lossy interfacial phases, can substantially elevate the total
848 loss. Furthermore, pores can store moisture or other impurities that can increase the dielectric
849 loss [170].

850 While the low sintering temperature can significantly affect the microwave dielectric
851 properties, the selection of an appropriate transient liquid phase is also crucial. This is because
852 various ceramic compounds exhibit differing solubilities, thereby requiring distinct transient
853 liquid phases for effective cold sintering. If the ceramic compounds undergo incongruent
854 dissolution, amorphous layers can be formed on the particle surfaces which limited the
855 precipitation process [57]. This phenomenon mainly occurs in perovskite and spinel compounds
856 which are hardly soluble in water. The formation of amorphous layers perturbs the overall
857 stoichiometry of the system. Moreover, this amorphous layer makes the mass transport between
858 liquid and solid interface more difficult thus impedes the nucleation or precipitation [57]. It is
859 suggested that, nanoparticles provide more lattice sites which facilitate the precipitation process
860 [171]. A study by H. Guo demonstrated the use of a $\text{Ba}(\text{OH})_2/\text{TiO}_2$ aqueous suspension instead of
861 pure water to prevent the incongruent phenomenon for the cold sintering of BaTiO_3 [172].
862 However, the impurity phase such as BaCO_3 occurs. This BaCO_3 phase is possibly formed
863 because the cold sintering process was done in an ambient environment where Ba can react to
864 CO_2 in the atmosphere. The present of BaCO_3 affects the electrical properties. Some studies have
865 used acidic and/or basic solutions to fabricate microwave dielectric ceramics, such as NaOH
866 solution, NaOH-KOH flux, acetic acid, oxalic acid, hydrochloric acid, or formic acid [150, 151,
867 173, 174]. After the cold sintering process, some ionic species, such as K^+ , Na^+ , and Cl^- , may
868 remain in the crystal structure. This substitutional incorporation consequently influences the
869 material's dielectric response. When cations or anions of different sizes are substituted, whether
870 on A-site or B-site, the bond length and bond strength are altered [175]. This can result in both its
871 dielectric permittivity (ϵ_r), quality factor and temperature coefficient of resonance frequency (τ_f)
872 [176-178].

873 Due to the low temperature processing, the cold sintering process has potential for co-
 874 sintering microwave dielectric ceramics with other components such as polymer, metal, or other
 875 nanoparticles forming composite materials and functionally graded materials. This process
 876 enables the integration of ceramics with polymers or other ceramics without thermal degradation.
 877 A composite between $\text{Na}_2\text{Mo}_2\text{O}_7$ microwave dielectric with polyetherimide (PEI) cold sintered at
 878 120°C for 20 minutes using DI water can achieve a high relative density in the range 94%-98%
 879 [155]. Li_2MoO_4 composited with PTFE represented relative density from 92%-98% after cold
 880 sintered at 120°C for 15-20 minutes. It is showed that as the concentration of PTFE increases, the
 881 temperature coefficient of resonant frequency is closer to zero (see Fig. 14) [179].



882
 883 **Fig. 14** (a) Effects of ceramic/polymer ratio on the properties of Li_2MoO_4 composited with PTFE.
 884 (b) Illustration of different amount of ceramic/polymer. (c) Microstructures of cold sintered
 885 ceramic-polymer Li_2MoO_4 composited with PTFE at composition of 90 Li_2MoO_4 -10PTFE and
 886 (d) 40 Li_2MoO_4 -60PTFE. (e) Permittivity, (f) quality factor, (g) temperature coefficient of
 887 resonant frequency. (h) Elastic modulus as a function of PTFE concentration [179].

888 Despite its revolutionary potential in temperature reduction, a critical analysis reveals that
 889 CSP currently faces significant performance trade-offs when compared to established LTCC and

890 emerging ultra-low temperature co-fired ceramic (ULTCC) technologies. While CSP enables
891 densification at unparalleled low temperatures ($<200^{\circ}\text{C}$), the resulting microwave dielectric
892 properties, particularly the quality factor, often lag behind. For instance, cold-sintered LiF and
893 molybdate-based systems typically exhibit $Q \times f$ values in the range of 10000–25000 GHz, with
894 exceptional cases reaching up to ~ 143000 GHz under optimized conditions [160, 161]. However,
895 these values are generally lower than those achieved by state-of-the-art LTCC and ULTCC
896 systems, which consistently deliver $Q \times f > 40000$ GHz and can exceed 100000 GHz [57, 180].
897 This performance gap is primarily attributed to the fundamental mechanisms of CSP: the
898 incomplete removal of the transient liquid phase (often water) leaves residual hydroxyl (OH^-)
899 groups, and the low-thermal-energy process promotes the formation of disordered amorphous
900 phases at grain boundaries. These features act as sources for dipolar relaxation and phonon
901 scattering, respectively, fundamentally limiting the achievable dielectric loss at microwave
902 frequencies.

903 Overcoming these intrinsic limitations is the central focus of current CSP research. A
904 promising strategy involves multi-stage processing, where a low-temperature cold sintering step
905 is followed by a controlled, moderate-temperature post-annealing step (*e.g.*, 400°C – 800°C).
906 This hybrid approach aims to leverage CSP for initial densification and shaping, while the
907 subsequent thermal treatment provides the necessary energy to drive off residual volatile species
908 and facilitate grain boundary crystallization, thereby significantly improving the $Q \times f$ value [69,
909 158]. Furthermore, research is actively exploring advanced solvent systems beyond deionized
910 water, including non-aqueous or chemically reactive transient phases that can promote congruent
911 dissolution and minimize the formation of undesirable amorphous intermediates. The integration
912 of CSP with other energy sources, such as microwave-assisted cold sintering, also presents an

913 intriguing pathway to enhance reaction kinetics at the particle-liquid interface. The ultimate goal
 914 is to engineer a CSP-based workflow that can produce ceramics with microstructures and
 915 properties comparable to high-temperature methods, thus unlocking its full potential as a truly
 916 disruptive and sustainable manufacturing technology for next-generation electronic devices. To
 917 provide a holistic overview, the key characteristics, advantages, and limitations of the three
 918 primary low-temperature sintering strategies discussed in this section are comparatively
 919 summarized in Table 5.

920 CC

921

922 **Table 5.** A comparative analysis of the primary strategies for low-temperature sintering of
 923 microwave dielectric ceramics, highlighting their respective mechanisms, typical performance
 924 ranges, and key challenges.

Parameter	Sintering aids (<i>e.g.</i> , Glass Additives)	Intrinsic low- T_s compounds (<i>e.g.</i> , Li-based)	Cold sintering process (CSP)
Typical sintering temperature	850 °C–950 °C	800 °C–950 °C	<200 °C (initial densification) + post-annealing (400 °C–900 °C)
Primary mechanism	Liquid-phase sintering	Enhanced solid-state diffusion	Pressure-assisted dissolution- precipitation
Typical $Q \times f$ (GHz)	40000–80000	50000–100000+	10000–30000 (can be higher)
Key advantage	Cost-effective, widely applicable	High $Q \times f$, intrinsic low loss	Unparalleled T reduction, Polymer/Metal Compatible
Primary limitation	Potential secondary phases, residual glass is lossy	Li volatilization, higher cost of some precursors	Lower $Q \times f$ (residual OH ⁻), Limited material systems

Future outlook	Multi-component glass design, glass-ceramics	Anion substitution (F ⁻), high-entropy designs	Hybrid processing (post-annealing), solvent engineering
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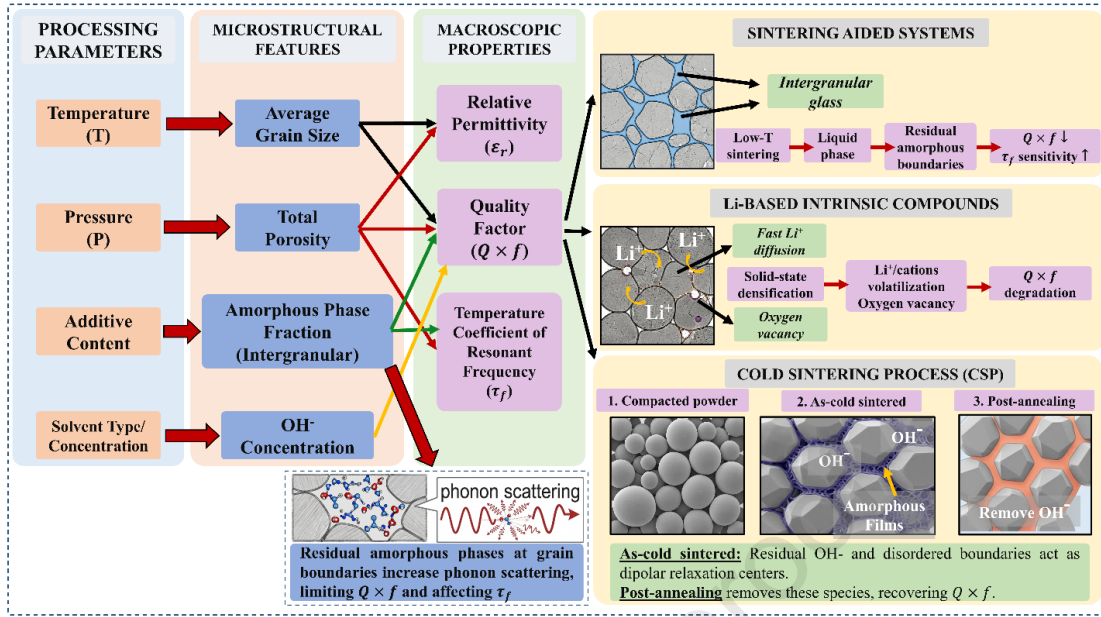
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926 While these academic advancements in sintering aids, intrinsic materials, and cold sintering
 927 demonstrate immense promise in the laboratory, their translation to high-volume manufacturing
 928 introduces a complex interplay of performance, cost, and reliability. The ultimate success of these
 929 materials is not judged by their properties alone, but by their ability to be integrated into robust,
 930 scalable production processes. The next section will therefore shift focus from the laboratory to
 931 the factory floor, exploring how industry leaders are navigating these challenges and
 932 commercializing low-temperature technologies through proprietary innovations and strategic
 933 material design.

934 **4.4 Unified Process-Structure-Property Framework**

935 The three low-temperature sintering strategies, sintering aids, intrinsically low-
 936 T_s compounds, and CSP, each achieve densification through distinct mechanisms, yet they
 937 converge on the same microstructure-property objectives: high density, clean grain boundaries,
 938 and minimal extrinsic losses (see Fig. 15). This unified lens allows direct comparison of
 939 trade-offs: sintering aids offer the widest compositional flexibility but at the cost of residual
 940 glass-related loss; intrinsic low- T_s compounds achieve higher $Q \times f$ (often >80000 GHz) but are
 941 largely limited to Li-rich chemistries; CSP enables unparalleled temperature reduction (<300 °C)
 942 but currently sacrifices $Q \times f$ unless a controlled post-anneal is applied. The following sections
 943 build on this framework to analyze industrial viability and future research directions.

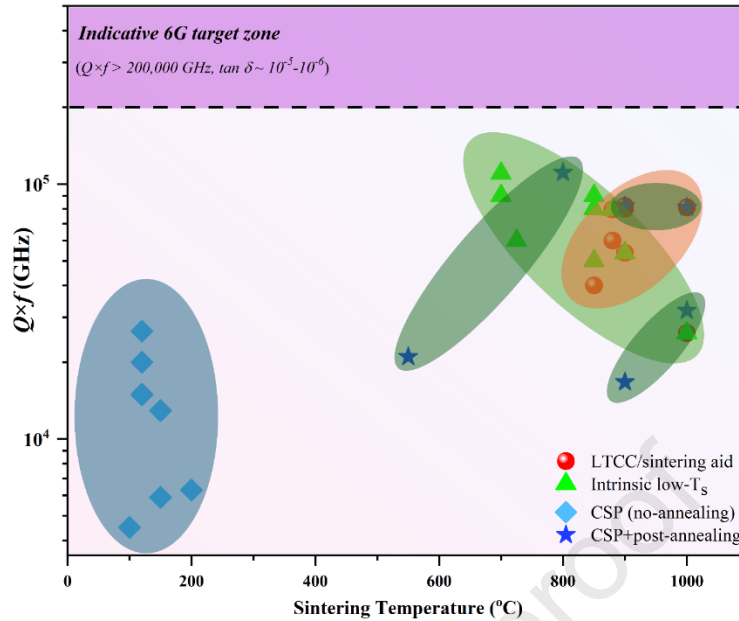
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945

946 **Fig. 15** Unified conceptual diagram linking processing, microstructure, and macroscopic
 947 properties in microwave dielectric ceramics.

948 To complement this conceptual framework, an Ashby-type plot (Fig. 16) compiles
 949 representative $Q \times f$ values as a function of sintering temperature for LTCC/sintering-aid systems,
 950 intrinsic low- T_s /ULTCC compounds, and CSP-processed ceramics. This quantitative overview
 951 highlights the distinct performance windows of each strategy and visualizes how CSP combined
 952 with post-annealing can partially close the gap towards LTCC/ULTCC, while still falling short of
 953 the projected sub-THz 6G requirements.



954

955 **Fig. 16** Ashby-type plot of sintering temperature versus $Q \times f$ for representative low-temperature
 956 microwave dielectric systems. Data points are taken from selected LTCC/sintering--aid
 957 compositions, intrinsic low- T_s /ULTCC compounds, and CSP-processed ceramics (with and
 958 without post-annealing), using values compiled in Tables 2–4. Shaded regions indicate typical
 959 performance windows for each strategy, highlighting the trade-off between sintering temperature
 960 and achievable $Q \times f$ and the current gap to sub-THz 6G targets.

961 5. Industrial Case Studies

962 The translation of academic breakthroughs in low-temperature microwave dielectric
 963 ceramics to high-volume manufacturing is a complex endeavor, fraught with technical, economic,
 964 and intellectual property challenges. While academic studies often prioritize record-low sintering
 965 temperatures or exceptionally high $Q \times f$ values, industrial LTCC development is fundamentally
 966 application-driven. Commercial systems must balance electrical performance with multilayer
 967 processability, thermal management, mechanical robustness, and long-term operational stability.
 968 Consequently, different industrial players have adopted distinct material-design philosophies and
 969 processing strategies depending on the targeted frequency regime and packaging requirements.

970 Within the unified process–structure–property framework developed in Section 4.4, these
971 industrial case studies can be viewed as distinct optimization choices along the axes of residual
972 glass content, interface stability, and processing window.

973 **5.1 Industry Leaders and Core Technologies**

974 Murata Manufacturing has long focused on low-loss, mechanically robust LTCC systems
975 based on controlled crystalline phase assemblages rather than highly glass-rich formulations. A
976 cornerstone of their technology, disclosed in patents like EP2397452B1, is a unique quartz-
977 alumina-fresnoite ($\text{Ba}_2\text{TiSi}_2\text{O}_8$) microstructure [181]. This design enables co-firing with Ag/Cu
978 electrodes below 1050°C while maintaining low permittivity ($\epsilon_r \leq 10$) and low loss ($\tan \delta < 0.001$).
979 The innovation lies in the controlled crystallization of the fresnoite phase, which enhances
980 thermal conductivity and mechanical strength, making these materials ideal for demanding
981 applications like millimeter-wave automotive radar (77–81 GHz) [182]. The primary challenge
982 remains silver migration, which Murata mitigates through crystalline barrier phases and surface
983 passivation [183]. Such crystallized systems are particularly attractive for millimeter-wave RF
984 modules and automotive radar applications because they minimize excessive residual glass
985 phases that can degrade dielectric performance at high frequencies. However, this approach
986 requires precise control of phase evolution during firing and introduces relatively narrow
987 processing windows for large-scale multilayer manufacturing.

988 Samsung Electro-Mechanics (SEMCO), in contrast, has concentrated heavily on
989 dimensional stability and multilayer registration control. Patented LTCC architectures employ
990 combinations of plate-like and globular ceramic particles within glass-assisted sintering matrices
991 to suppress x - y shrinkage and improve alignment precision in multilayer structures [184]. This
992 approach is vital for the high-yield production of fine-line (>30 layers) RF substrates for 5G,

993 enabling tight inter-layer registration ($<15\ \mu\text{m}$) required for complex 3D structures with
994 embedded cavities and passives [185]. TDK Corporation targets the IoT and high-frequency filter
995 markets with tunable BaO-TiO₂-SiO₂ glass-ceramic composites ($\epsilon_r=6-15$) designed for sintering
996 below 900°C [186]. Their foundational patents (*e.g.*, JP S51143898A) [187] and subsequent
997 innovations focus on proprietary sintering additives (*e.g.*, MnO₂, Nd₂O₃) that promote liquid-
998 phase sintering while -preserving high quality factors ($Q \times f > 40,000\ \text{GHz}$) [184]. Like Murata,
999 TDK grapples with silver migration and humidity-related degradation, which they address with
1000 protective surface passivation layers. Such materials remain commercially relevant for sub-6
1001 GHz communication modules, IoT devices, and RF filters because they provide a practical
1002 balance among dielectric performance, manufacturability, and cost. However, residual amorphous
1003 phases and liquid-phase sintering routes may limit performance under mm-Wave conditions and
1004 increase susceptibility to humidity-related degradation or interfacial instability.

1005 Vibrantz Technologies (formerly Ferro Electronic Materials) has specifically targeted
1006 high-frequency 5G applications requiring ultra-low dielectric loss and enhanced thermal
1007 management. Commercial LTCC tape systems such as A6M-E and M7 are designed for operation
1008 in the 10-60 GHz range and emphasize low insertion loss, stable dielectric behavior, high thermal
1009 conductivity, and mechanical robustness [188]. Based on a magnesium-silicate composition, this
1010 system achieves an extremely low loss tangent ($\tan \delta < 0.0003$ at 10 GHz) and high thermal
1011 conductivity ($\lambda > 4\ \text{W} \cdot \text{m}^{-1} \cdot \text{K}^{-1}$) after sintering at 850 °C. This demonstrates a clear industry trend
1012 towards developing specialized material systems optimized for specific frequency bands and
1013 performance targets, rather than a one-size-fits-all approach.

1014 Despite targeting similar low-temperature co-firing applications, these industrial strategies
1015 differ substantially in their optimization priorities, processing philosophies, and targeted

1016 operating frequency ranges. Murata-type crystallized systems prioritize dielectric stability and
1017 mechanical reliability for demanding high-frequency environments, whereas SEMCO emphasizes
1018 dimensional precision and multilayer manufacturability. TDK-type glass-ceramic systems remain
1019 attractive for scalable and cost-sensitive applications, while Vibrantz focuses explicitly on ultra-
1020 low-loss performance for emerging mm-Wave and advanced 5G packaging technologies.

1021 **5.2 Analysis and Emerging Trends**

1022 The comparative industrial landscape reveals that no universal LTCC material platform
1023 currently satisfies all requirements for next-generation wireless communication systems. Instead,
1024 industrial development is increasingly application-specific, with different material systems
1025 emerging for sub-6 GHz infrastructure, mm-Wave RF modules, automotive radar, heterogeneous
1026 integration, and prospective 6G packaging technologies.

1027 For sub-6 GHz applications and IoT devices, conventional glass-ceramic LTCC systems
1028 remain commercially dominant because cost efficiency, multilayer scalability, and moderate
1029 dielectric performance are prioritized over achieving the lowest possible dielectric loss. In
1030 contrast, mm-Wave applications operating above ~24 GHz impose significantly stricter
1031 requirements on dielectric loss, thermal conductivity, conductor-interface stability, and
1032 dimensional precision. Under these conditions, crystallized low-glass systems and highly
1033 optimized low-loss composites become increasingly attractive.

1034 This trend is strongly reflected in recent industrial patents and emerging ultra-low-
1035 temperature co-fired ceramic (ULTCC) systems. Recent developments increasingly move away
1036 from conventional silicate-rich LTCC chemistry toward molybdates [189], tungstates [190],
1037 vanadates [191], and chemically engineered composite systems capable of densification below
1038 ~700 °C. Lower processing temperatures not only reduce manufacturing energy consumption,

1039 but also mitigate thermally activated interfacial diffusion and conductor migration, thereby
 1040 improving compatibility with Ag, Cu, and potentially even Al metallization.

1041 At the same time, the industrial emphasis is gradually shifting from merely lowering
 1042 sintering temperature toward holistic optimization of process-structure-property relationships.
 1043 Future commercial competitiveness will likely depend on simultaneously balancing dielectric
 1044 loss, shrinkage behavior, thermal transport, multilayer integration capability, reliability, and
 1045 manufacturing yield rather than maximizing a single dielectric parameter alone.

1046

1047

1048 **Table 6** Comparative positioning of representative industrial LTCC strategies for high-frequency
 1049 applications

Industrial route	Main strategy	Key advantage	Main limitation	Most suitable application
Murata-type crystallized LTCC	Controlled crystalline phase assemblage	High dielectric stability and mechanical robustness	Narrow processing window	77-81 GHz automotive radar, high-reliability mmWave RF modules
SEMCO dimensional-control LTCC	Platelet-assisted shrinkage control	Excellent multilayer registration	Glass-assisted loss/reliability trade-offs	High-density 24-40 GHz RF substrates and embedded passive architectures
TDK glass-ceramic LTCC	Glass-assisted low-temperature densification	Scalable and cost-effective manufacturing	Residual glass-related dielectric limitations	Sub-6 GHz 5G modules, IoT devices, RF filters
Vibrantz/Ferro low-loss LTCC	Ultra-low-loss RF packaging system	Excellent mm-Wave dielectric performance	Higher process/material complexity	24-60 GHz 5G mmWave packaging

				and high-speed RF
				interconnect
				Prospective 6G sub-
Emerging ULTCC	Ultra-low-temperature	Reduced interfacial	Limited industrial	THz and
systems	densification	diffusion and lower	maturity	heterogeneous
		thermal budg		integration platform

1050

1051 The comparative analysis indicates that no single LTCC platform is universally optimal
1052 across all 5G and 6G frequency regimes. Conventional glass-ceramic LTCC systems remain the
1053 most practical solution for sub-6 GHz communication modules due to their scalability and cost
1054 efficiency. However, as operating frequencies move toward the FR2 mm-Wave regime (>24
1055 GHz), dielectric loss, conductor-interface stability, and thermal management become increasingly
1056 critical, favoring crystallized low-glass systems and specialized ultra-low-loss LTCC platforms.
1057 For automotive radar operating at 77–81 GHz, mechanically robust crystallized systems appear
1058 more advantageous than highly glass-rich formulations because of their superior thermal and
1059 dimensional stability. Meanwhile, emerging ULTCC systems are considered among the most
1060 promising candidates for future 6G and sub-THz applications due to their lower thermal budgets
1061 and improved compatibility with advanced metallization and heterogeneous integration
1062 schemes, particularly when combined with appropriate metallization and packaging strategies.

1063 **5.3 Critical Manufacturing Barriers and Future Outlook**

1064 Despite substantial progress, several critical barriers continue to limit the broader
1065 commercialization of advanced LTCC and ULTCC technologies, particularly for high-frequency
1066 5G mm-Wave and prospective 6G applications.

- 1067 • **Interface Stability:** Conductor-related degradation remains one of the most persistent
1068 reliability challenges in co-fired ceramic systems. Silver migration, interfacial diffusion,

1069 and chemically induced dielectric degradation become increasingly severe as operating
1070 frequencies move toward the mm-Wave and sub-THz regime. In conventional glass-rich
1071 LTCC systems, residual amorphous phases may accelerate ionic diffusion and interfacial
1072 instability during long-term operation. Consequently, industrial strategies are evolving
1073 beyond passive diffusion barriers toward intrinsically compatible low-temperature
1074 chemistries, reduced-glass or glass-free crystallized systems, and ultra-low-temperature
1075 processing routes that minimize thermally activated diffusion processes. This trend is
1076 particularly important for future heterogeneous integration schemes involving Ag, Cu,
1077 and potentially Al metallization.

1078 • **Dimensional Control:** As integration density increases, maintaining dimensional
1079 precision during co-firing becomes increasingly difficult. High-density RF substrates
1080 operating in the FR2 mm-Wave regime require extremely tight interlayer registration,
1081 controlled shrinkage behavior, and defect-free multilayer architectures. Even minor
1082 dimensional variations can significantly affect impedance matching, insertion loss, and
1083 signal integrity at high frequencies. These requirements are driving continued innovation
1084 in tape-casting formulations, particle morphology engineering, lamination protocols, and
1085 real-time process monitoring. In particular, digital-twin-assisted manufacturing and AI-
1086 enabled process optimization are emerging as promising approaches for improving
1087 manufacturing reproducibility and yield in complex multilayer LTCC systems.

1088 • **Cost vs. Performance:** Although LTCC technologies provide substantial advantages in
1089 integration density, thermal stability, and high-frequency performance, manufacturing
1090 costs remain significantly higher than those of conventional polymer-based substrates
1091 such as FR-4. This economic barrier becomes particularly important in cost-sensitive

1092 commercial 5G infrastructure and consumer electronics markets. As a result, current
1093 industrial efforts increasingly focus on reducing firing temperatures, simplifying
1094 multilayer fabrication routes, and replacing expensive or scarce raw materials with lower-
1095 cost alternatives. The growing interest in molybdate-, tungstate-, and vanadate-based
1096 ULTCC systems reflects not only dielectric-performance considerations, but also broader
1097 economic and sustainability pressures associated with large-scale manufacturing.

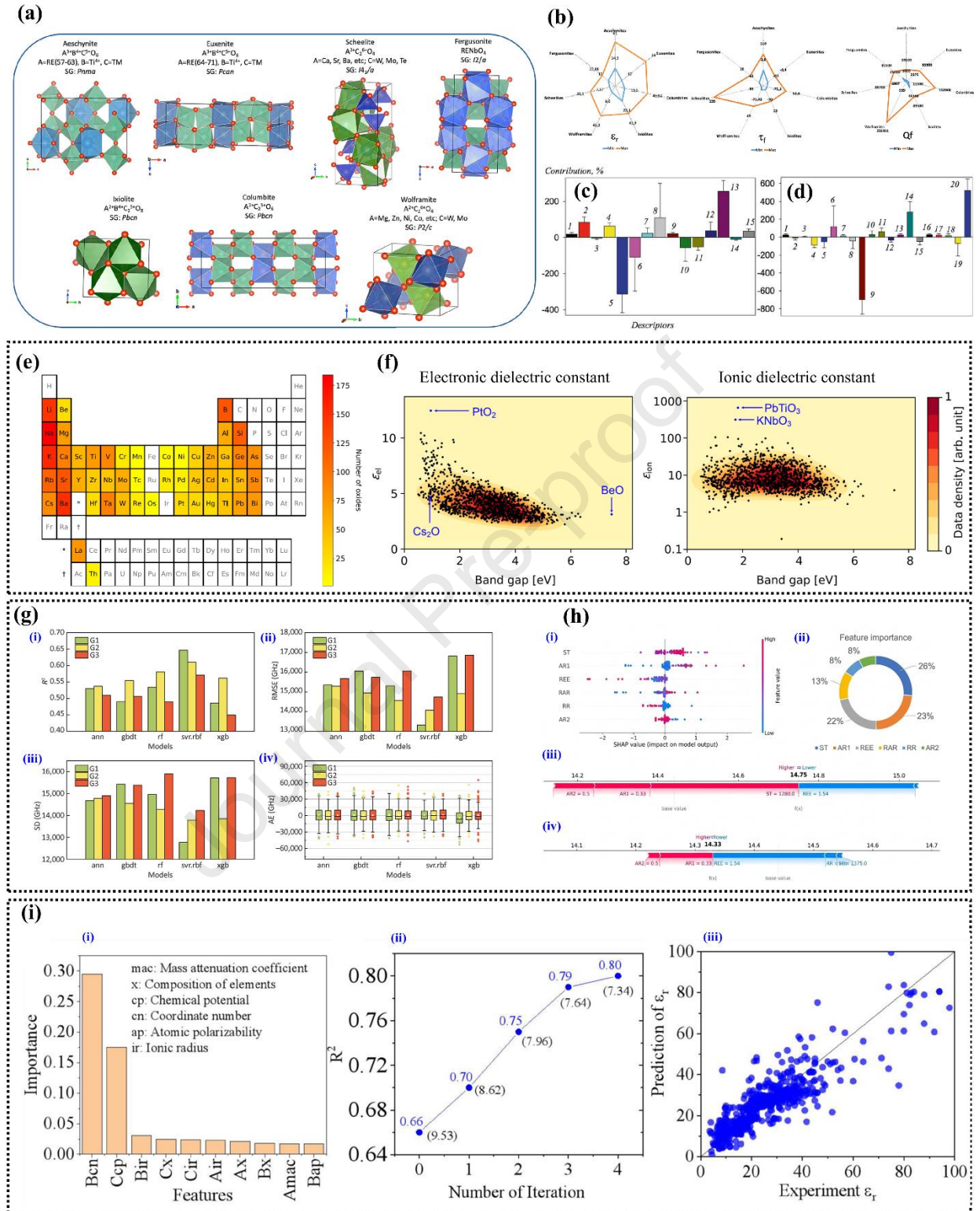
1098 Overall, the industrial trajectory of low-temperature microwave dielectric ceramics is shifting
1099 from general-purpose LTCC formulations toward application-specific material platforms
1100 optimized for distinct frequency windows and packaging requirements. Conventional glass-
1101 ceramic LTCC systems are expected to remain commercially dominant for sub-6 GHz
1102 communication modules and IoT applications due to their scalability and cost efficiency. In
1103 contrast, crystallized low-glass systems and ultra-low-loss composite LTCC platforms are
1104 becoming increasingly attractive for FR2 mm-Wave applications because of their improved
1105 dielectric stability and thermal reliability. For future 6G and sub-THz technologies, emerging
1106 ULTCC and glass-free or low-glass crystalline systems appear particularly promising due to their
1107 reduced thermal budgets, lower interfacial diffusion, and compatibility with heterogeneous
1108 integration architecture.

1109 Moreover, the enormous compositional and processing parameter space associated with
1110 LTCC and ULTCC materials makes conventional trial-and-error optimization increasingly
1111 inefficient. The industrial challenges discussed above, from controlling conductor diffusion to
1112 achieving zero-shrinkage multilayer integration, highlight the growing need for predictive, data-
1113 driven materials design approaches. Consequently, computational modeling, high-throughput
1114 screening, and artificial intelligence-assisted materials discovery are expected to play increasingly

1115 important roles in accelerating the development of next-generation microwave dielectric ceramics
1116 for advanced 5G and 6G communication systems.

1117 **6. Cross-disciplinary approaches**

1118 Artificial intelligence (AI) and computational modeling have emerged as powerful tools for
1119 accelerating the discovery and design of new ceramic materials. By using machine learning
1120 algorithms, researchers can analyze numerous experimental and theoretical data to determine
1121 trends, correlations, and potential material candidates. This data-driven approach significantly
1122 reduces the time and cost of traditional methods. By employing machine learning algorithms
1123 such as random forests, neural networks, and Bayesian optimization, researchers can rapidly
1124 screen thousands of candidate chemistries for targeted dielectric properties (*e.g.*, ϵ_r , $Q \times f$, τ_f).
1125 Additionally, computational modeling techniques, such as DFT and molecular dynamics
1126 simulations, can be used to predict the structural, electronic, and dielectric properties of materials,
1127 enabling the design of tailored materials with desired properties.



1128

1129 **Fig. 17** A summary of data-driven and computational approaches for accelerating the design and

1130 understanding of microwave dielectric ceramics. (a) Crystal structures and (b) property ranges

1131 $(\epsilon_r, Q \times f, \tau)$ for seven common families of microwave dielectric ceramics from experimental
1132 datasets. (c,d) Contribution analysis of various descriptors to ϵ_r for aeschynites/euxenites and
1133 columbites/ixiolites/wolframites, respectively, highlighting the significant impact of processing
1134 parameters alongside intrinsic properties (adapted from Kireeva *et al.* [192]). (e) The distribution
1135 of cation species within a large-scale computational database of ~ 1200 oxides generated via first-
1136 principles calculations. (f) Computationally derived distributions showing the distinct behaviors
1137 of the electronic (ϵ_{el}) and ionic (ϵ_{ion}) contributions to the dielectric constant as a function of the
1138 material's band gap (adapted from Takahashi *et al.* [193]). (g) A methodological comparison of
1139 different machine learning algorithms and feature engineering strategies for predicting the
1140 challenging quality factor ($Q \times f$) property in ABO_4 -type ceramics, evaluated by (i) R^2 , (ii) RMSE,
1141 (iii) standard deviation, and (iv) absolute error (adapted from Mo *et al.* [194]). (h) An example of
1142 explainable AI (XAI) using SHAP analysis for rock-salt structures, showing (i) the swarm plot of
1143 feature impacts, (ii) the overall feature importance, and (iii, iv) force plots explaining the
1144 prediction for individual samples (adapted from Liu *et al.* [195]). (i) An illustration of an
1145 interpretable "white-box" model development using the SISSO method, showing (i) initial feature
1146 importance ranking, (ii) the iterative improvement of model accuracy (R^2), and (iii) the final
1147 high-fidelity correlation between the model's predictions and experimental ϵ_r values (adapted
1148 from Sheng *et al.* [121]).

1149 The application of computational and ML techniques in microwave dielectric ceramics
1150 has rapidly matured from initial feasibility studies to the generation of sophisticated, physically
1151 interpretable design principles, as summarized in Fig. 17. The synergy between high-throughput
1152 computation, advanced ML algorithms, and interpretable methods provides a powerful toolkit for
1153 navigating the complex materials landscape required for next-generation wireless technologies.

1154 A foundational step in this data-driven paradigm involves building robust models from
1155 extensive experimental datasets. Kireeva *et al.* [192] exemplified this by analyzing data for seven
1156 distinct structural families, including aeschynites and wolframites (Fig. 17 (a-b)). A key
1157 innovation in their work was the holistic inclusion of processing parameters (e.g., sintering
1158 temperature and time) as crucial descriptors, demonstrating that ML can decode the complex
1159 interplay between composition, structure, and synthesis pathways. The contribution analysis (Fig.
1160 17 (c-d)) highlights that these processing-related features have a significant impact on the final
1161 dielectric properties, bridging the gap between theoretical composition and real-world material
1162 performance. Notably, several of the most influential descriptors identified in these studies-such
1163 as sintering temperature, dwell time, and defect-related structural metrics-map directly onto the
1164 process-structure-property axes discussed in Section 4.4, reinforcing the mechanistic framework
1165 developed earlier in this review.

1166 To overcome the inherent noise in experimental data, a complementary strategy is to generate
1167 large, self-consistent datasets using high-throughput first-principles calculations. Takahashi *et al.*
1168 [193] pursued this computational route, constructing a database of ~1200 metal oxides. Their
1169 work provided a deeper physical insight by separately modeling ϵ_{el} and ϵ_{ion} contributions to the
1170 relative permittivity. As shown in Fig. 17f, they confirmed the inverse correlation between ϵ_{el}
1171 and the band gap, while revealing that the much larger ϵ_{ion} has a far more complex relationship,
1172 underscoring the power of computation to deconstruct a property into its fundamental
1173 components.

1174 Building on these approaches, ML has been applied to predict specific and challenging
1175 properties. The quality factor ($Q \times f$) is notoriously difficult to model due to its sensitivity to subtle
1176 defects and lattice anharmonicity. Mo *et al.* [194] tackled this by developing a predictive model

1177 for ABO₄-type ceramics, demonstrating through systematic algorithm and feature selection that
1178 support vector regression (SVR) could achieve high accuracy in predicting $Q \times f$ (Fig. 17g). As
1179 ML models become more sophisticated, attention has shifted towards improving their
1180 interpretability. Liu *et al.* [195] employed explainable AI (XAI) using SHapley Additive
1181 explanations (SHAP) for rock-salt structured ceramics. Their analysis (Fig. 17h) moved beyond
1182 “black-box” predictions by definitively quantifying the importance of each feature, identifying
1183 sintering temperature, atomic ratio, and electronegativity as the most critical factors, and
1184 explaining how they influence the prediction for any individual sample.

1185 The ultimate goal is the creation of “white-box” models that yield explicit, physically
1186 meaningful formulas. Sheng *et al.* [121] achieved this using the Sure Independence Screening
1187 and Sparsifying Operator (SISSO) method. Their work not only generated an interpretable model
1188 with high fidelity ($R^2 \sim 0.8$) but also proposed a novel strategy to merge datasets of different
1189 component numbers. By iteratively building a physically transparent descriptor, as shown in Fig.
1190 17i, their approach represents the frontier of data-driven materials science: using ML not just to
1191 predict, but to discover the underlying physical laws governing material properties.

1192 **6.1 Cross-Study Comparison of Model Performance**

1193 To enable direct comparison across different ML studies, Table 7 summarizes key works
1194 on microwave dielectric ceramics, including dataset sizes, algorithms, target properties, and
1195 quantitative performance metrics. As shown, the R^2 values for $Q \times f$ prediction typically lie
1196 between 0.78 and 0.81, indicating room for improvement before industrial adoption (where $R^2 >$
1197 0.95 is often desired). Notably, the XGBoost model for τ_f prediction achieved an R^2 of 0.7799,
1198 identifying molecular dielectric polarizability (p_m), tolerance factor (t), ionic volume (V_i), and
1199 relative molecular mass (m) as the most critical features [188]. For ϵ_r prediction in rock-salt

1200 systems, a high R^2 of 0.9376 was achieved using only six key features, with sintering temperature,
 1201 atomic ratio, and electronegativity contributing approximately 71% to the prediction accuracy
 1202 [12]. The SISSO approach, while sacrificing some accuracy ($R^2 \sim 0.8$), provides an interpretable,
 1203 closed-form equation for ϵ_r that can be used without running the ML model itself [190]. This
 1204 comparison also highlights a clear research frontier: closing the gap between current model
 1205 performance and the reliability levels required for industrial LTCC/ULTCC and CSP process
 1206 control.

1207 **Table 7** Cross-study comparison of machine learning models for microwave dielectric ceramics

Target property	Dataset size	Model(s)	Best performance	Key features identified	Ref.
$\epsilon_r, Q \times f, \tau$	~300 (7 structural families)	Random Forest, etc.	Contribution analysis of processing parameters	T_s and time as crucial descriptors	[192]
$Q \times f$ (ABO ₄ -type)	164	SVR, RF, XGBoost, etc	SVR (RBF): $R^2=0.8115$, RMSE=8,362 GHz	Structural features, 35 input descriptors	[194]
ϵ_r, τ (multiple systems)	254 (for ϵ_r)	RF, GBR, SVR, etc	ϵ_r : RMSE=4.84; τ : RMSE=21.86	32 intrinsic chemical, structural, and thermodynamic features	[196]
ϵ_r (ternary/quaternary oxides)	1,419	SISSO (white-box)	$R^2 \approx 0.8$ (quaternary)	Derived explicit physical formula	[121]

τ_f (ABO ₃ -type)	104	XGBoost, RF, SVR, etc.	XGBoost: $R^2=0.7799$, RMSE=15.75 ppm/°C	ρ_m (molecular polarizability), t (tolerance factor), V_i , m	[197]
ϵ_r (rock-salt)	Not specified	XGBoost + INFO optimization	$R^2=0.9376$, MAE=0.5249	T_s , atomic ratio, electronegativity (~71% contribution)	[195]

1208

1209 6.2 Current challenges and future directions for ML in microwave dielectrics

1210 Despite significant progress, several critical challenges remain.

- 1211 - Data scarcity: Experimental datasets in MWDC research are typically limited to 100–300
- 1212 samples, which is small by ML standards. This scarcity constrains model generalizability
- 1213 and increases the risk of overfitting. Several strategies are being pursued to mitigate this
- 1214 issue: (i) NLP-based data mining from the literature, Wang *et al.* constructed a pipeline to
- 1215 extract normalized property data from approximately 12,900 dielectric ceramics articles,
- 1216 achieving micro-F1 scores exceeding 90% for sentence classification and relation
- 1217 extraction [198]; (ii) generative virtual sample generation, data augmentation techniques
- 1218 can artificially expand small datasets; (iii) transfer learning, pre-training models on
- 1219 related tasks with larger datasets; and (iv) active learning, iteratively selecting the most
- 1220 informative samples for experimental validation [199, 200].
- 1221 - Lack of benchmark datasets: Unlike computer vision (e.g., ImageNet), the MWDC
- 1222 community lacks standardized, open-access benchmark datasets for fair model
- 1223 comparison. MatBench, developed by the Materials Project, offers curated benchmarking
- 1224 tasks for general materials properties (band gaps, elastic moduli, formation energies, etc.)
- 1225 but does not yet include microwave-specific properties such as ϵ_r , $Q \times f$, or τ_f [200]. The
- 1226 field would greatly benefit from community-driven efforts to establish such benchmarks.

- 1227 - Prediction-experiment validation gap: Many ML studies achieve high accuracy on held-
1228 out literature data, but their predictions are rarely validated through actual synthesis and
1229 measurement. This gap arises from differences in synthesis protocols, measurement
1230 conditions, and the inherent noise in literature-compiled data. Encouragingly, recent
1231 studies have begun to address this issue. For rock-salt ceramics, the ML model's
1232 predictions were experimentally validated on two different material compositions
1233 ($\text{LiMg}_8\text{AlO}_{10}$ and Li_2SnO_3 -doped $\text{Li}_3\text{MgNbO}_5$), confirming its predictive capability
1234 beyond the training distribution [195]. Moreover, closed-loop autonomous
1235 experimentation systems that combine ML prediction with automated synthesis and
1236 characterization are emerging as a powerful solution to close the feedback loop and
1237 accelerate materials discovery [199].
- 1238 - Bridging the gap: The ultimate goal is to integrate AI, high-throughput computation, and
1239 autonomous experimentation into a unified workflow. By using AI to guide computational
1240 simulations, which in turn inform nanoscale materials design, the development timeline
1241 could be reduced from years to months. Several research groups are already pursuing
1242 such integrated platforms, and their success will be instrumental in delivering the next
1243 generation of low-temperature microwave dielectrics for 6G and beyond.

1244 The synergy between AI-driven discovery, high-throughput computation, and advanced
1245 synthesis not only promises to accelerate the development of high-performance materials but also
1246 enables a more efficient and targeted approach to manufacturing. This optimization of resources
1247 and reduction in experimental waste naturally aligns with broader global goals. Beyond pure
1248 performance, the drive towards low-temperature processing is fundamentally linked to the critical

1249 imperatives of sustainability and economic viability, which will be discussed in the following
1250 section.

1251 **7. Sustainability and economic impact**

1252 **7.1 Energy consumption reduction**

1253 The transition from conventional high-temperature sintering to low-temperature
1254 approaches represents a paradigm shift in ceramic manufacturing sustainability. Traditional
1255 microwave dielectric ceramics require sintering temperatures above 1000 °C, with some systems
1256 demanding temperatures as high as 1400 °C for cordierite-based materials [201, 202]. In stark
1257 contrast, recent advances in low-temperature sintering have demonstrated remarkable temperature
1258 reductions. Ultra-low temperature sintering of molybdate-based ceramics can achieve full
1259 densification at temperatures as low as 550 °C–600 °C [202], representing energy savings of up
1260 to 50% compared to conventional processing [201].

1261 A quantitative comparison of energy consumption across different sintering techniques,
1262 compiled by J. Andrews, reveals dramatic differences [203]. Conventional solid-state sintering of
1263 BaTiO₃ consumes 2800 kJ·g⁻¹, while liquid-phase sintering consumes 2000 kJ·g⁻¹. Field-assisted
1264 sintering, microwave sintering, and fast firing consume 1050 540, and 130 kJ·g⁻¹, respectively. In
1265 striking contrast, CSP consumes only 30 kJ·g⁻¹, representing a 98.9% reduction relative to
1266 conventional solid-state sintering. This dramatic saving is achieved by combining a transient
1267 liquid phase (typically water) with applied uniaxial pressure at temperatures mostly below 300
1268 °C. However, as discussed in Section 4.3, these dramatic energy savings must be balanced against
1269 the current limitations in $Q \times f$ and microstructural perfection for ultra-high- Q applications.

1270 For ULTCC systems, the Fraunhofer Institute for Ceramic Technologies and Systems
1271 states that ULTCCs can be sintered at very low temperatures of 400 °C to 700 °C, making their

1272 manufacturing process very energy-efficient [204]. The NAT-ULTCC project further quantifies
1273 that reducing the sintering temperature from 850–1000 °C down to below 600 °C lowers energy
1274 consumption in the sintering phase by at least 30% [205]. A techno-economic analysis by T.
1275 Ibn-Mohammed *et al.* (2019) concluded that CSP offers the lowest capital cost, the best return on
1276 investment, and the most considerable combined energy and emission savings among the
1277 methods examined [183].

1278 **7.2 Carbon Footprint Reduction**

1279 Ultra-low temperature co-fired ceramics processed at 470 °C represent a breakthrough in
1280 sustainable manufacturing, achieving properties suitable for high-frequency applications while
1281 operating within temperature ranges accessible to renewable heating technologies [206]. The
1282 NAT-ULTCC project's $\geq 30\%$ energy reduction target, when combined with the replacement of
1283 precious-metal electrodes (Ag, Au) by base metals (Al), further lowers both material cost and
1284 embodied carbon. It must be noted, however, that the concept of fully “carbon-neutral” ceramic
1285 manufacturing remains a forward-looking target rather than a current reality. The transition will
1286 require not only low-temperature processing but also widespread adoption of renewable-electricity
1287 heating, hydrogen-based burners, or carbon-capture technologies, as highlighted in recent
1288 roadmaps for the European ceramic industry [207].

1289 The dramatic reduction in energy consumption afforded by low-temperature sintering
1290 directly translates to lower operational CO₂ emissions, especially when the electricity used is
1291 sourced from renewable generation. T. Ibn-Mohammed *et al.* estimated, using marginal
1292 abatement cost curve methods, that cold sintering can achieve substantial CO₂ savings per ton of
1293 ceramic produced compared with conventional solid-state and liquid-phase sintering, although

1294 the exact saving depends on the specific ceramic composition, production scale, and local energy
1295 mix [183].

1296 **7.3 Economic benefits and cost reduction**

1297 The economic advantages of low-temperature sintering have been quantitatively analyzed
1298 by T. Ibn-Mohammed *et al.* [183]. Using marginal abatement cost curves, they showed that cold
1299 sintering offers the lowest capital cost and the best return on investment among all sintering
1300 techniques compared. Energy-efficient sintering technologies can reduce production costs
1301 through decreased fuel consumption, shortened processing cycles, and reduced equipment
1302 maintenance.

1303 Low-temperature compatible silver metallization systems enable cost-effective electrode
1304 integration in LTCC applications, eliminating the need for expensive platinum or palladium
1305 conductors, substantially reducing metallization costs for LTCC and ULTCC manufacturing
1306 [188].

1307 **7.4 Life-cycle comparison of sintering strategies**

1308 To provide a quantitative comparison, Table 8 summarizes key metrics for the four
1309 sintering strategies discussed in this review. This table draws exclusively on LTCC/ULTCC/CSP-
1310 specific literature, not on generic ceramic statistics.

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1314

1315 **Table 8** Comparative life-cycle assessment (LCA) metrics for low-temperature sintering
1316 strategies.

Sintering strategy	Typical T_s (°C)	Relative energy consumption		Ref
		(Compared to conventional sintering)	CO ₂ saving potential	
Conventional	1200–1600	100% (baseline, 2800 kJ·g ⁻¹)	-	[203]
Sintering aids/LTCC	850–950	~50%–70% of baseline	Moderate; avoids high-temp. volatilization	[183]
Intrinsic low- T_s (ULTCC)	400–700	≤30% of baseline*	Significant; enables Al co-firing	[205]
Cold sintering (CSP)	<300 (Plus post-annealing)	≤1.1% of baseline**	Largest; applicable to many compositions	[203]

1317 * Based on NAT-ULTCC project target of ≥30% energy reduction vs. LTCC baseline.

1318 ** Based on CSP energy consumption of 30 kJ·g⁻¹ vs. 2,800 kJ·g⁻¹ for conventional sintering.

1319 7.5 Future Sustainability Outlook

1320 Comprehensive life-cycle assessments for LTCC substrates have identified the co-firing
 1321 step as the dominant environmental hotspot, which low-temperature strategies directly address
 1322 [208]. The convergence of low-temperature sintering technologies with renewable energy
 1323 systems and circular economy principles positions microwave dielectric ceramics manufacturing
 1324 for substantial sustainability improvements. Government initiatives supporting green
 1325 manufacturing, including the European Green Deal and various national decarbonization
 1326 strategies, provide policy frameworks encouraging adoption of energy-efficient ceramic
 1327 processing technologies.

1328 Advanced manufacturing concepts like energy-aware 6G networks emphasize the
 1329 importance of sustainable materials and processing technologies, creating market demand for
 1330 environmentally responsible microwave components. The integration of artificial intelligence
 1331 and machine learning in ceramic processing optimization further enhances the economic and

1332 environmental benefits of low-temperature sintering by enabling precise control of processing
1333 parameters and reducing material waste.

1334 In principle, Cold sintering processes demonstrate particular promise for carbon capture
1335 integration, potentially enabling atmospheric CO₂ utilization in ceramic precursor materials while
1336 achieving room-temperature consolidation. This approach represents a paradigm shift from
1337 traditional ceramic manufacturing, transforming the industry from a carbon emitter to a potential
1338 carbon sink [209].

1339 This transformation toward sustainable ceramic manufacturing represents not only an
1340 environmental imperative but also a competitive advantage for manufacturers adopting
1341 low-temperature processing technologies. The combination of reduced energy consumption,
1342 lower production costs, improved material properties, and enhanced market positioning creates a
1343 compelling case for industry-wide adoption.

1344 **8. Future trends and research directions**

1345 **8.1 The next frequency frontier: from millimeter-Wave to Terahertz**

1346 The convergence of low-temperature sintering technologies (LTCC, ULTCC, and cold
1347 sintering) with the demanding specifications of 5G/6G communication systems represents the
1348 most critical trajectory for microwave dielectric ceramics research. As 5G networks transition to
1349 millimeter-wave frequencies (24–71 GHz) and 6G explores sub-terahertz bands (100–300 GHz),
1350 low-temperature co-fireable ceramics enable the miniaturization, cost reduction, and high-density
1351 integration essential for massive MIMO antenna arrays, small-cell base stations, and phased-
1352 array transceivers [55].

1353

1354 **8.2 Advancements in low-temperature Co-fired technologies**

1355 Addressing the formidable challenges of the millimeter-wave and terahertz frontier requires a
1356 multi-pronged approach to materials processing. The following section details the technological
1357 advancements across three critical tiers of low-temperature co-firing technologies. We begin by
1358 examining the breakthroughs that have pushed conventional LTCC into the 5G millimeter-wave
1359 domain. Subsequently, we explore the "next frontier" of ULTCC and the CSP, which promise to
1360 overcome the fundamental limitations of LTCC by enabling co-integration with a wider range of
1361 materials and drastically reducing the manufacturing energy footprint

1362 **8.2.1 LTCC technology breakthroughs for millimeter-wave 5G**

1363 Traditional LTCC implementations were historically limited to operating frequencies below
1364 10 GHz due to material loss and conductor constraints. However, recent innovations in
1365 proprietary dielectric compositions, distributed filter topologies, and advanced conductive pastes
1366 have extended LTCC capabilities to millimeter-wave frequencies exceeding 40 GHz, with
1367 commercial filters now available for 5G FR2 bands (n257, n258, n260, n261) operating at 26 –
1368 28 GHz and 37- 40 GHz. These LTCC components achieve footprints 75% smaller than thin-
1369 film-on-alumina alternatives at one-quarter the cost, while maintaining superior environmental
1370 robustness through internally shielded structures that prevent detuning after board assembly
1371 [210]. For massive MIMO architectures requiring thousands of antenna elements, LTCC-based
1372 wideband patch antennas demonstrate impedance bandwidths exceeding 20% at Ka-band (28
1373 GHz) with compact multilayer structures ($4.88 \times 4.88 \times 1.036 \text{ mm}^3$) suitable for dense array
1374 integration. High-performance millimeter-wave front-end modules co-integrate filters, couplers,
1375 and transmission lines on LTCC substrates sintered at 850°C - 900°C with silver electrodes,
1376 achieving insertion losses below 2 dB and return losses exceeding 15 dB across 24-30 GHz bands
1377 [211].

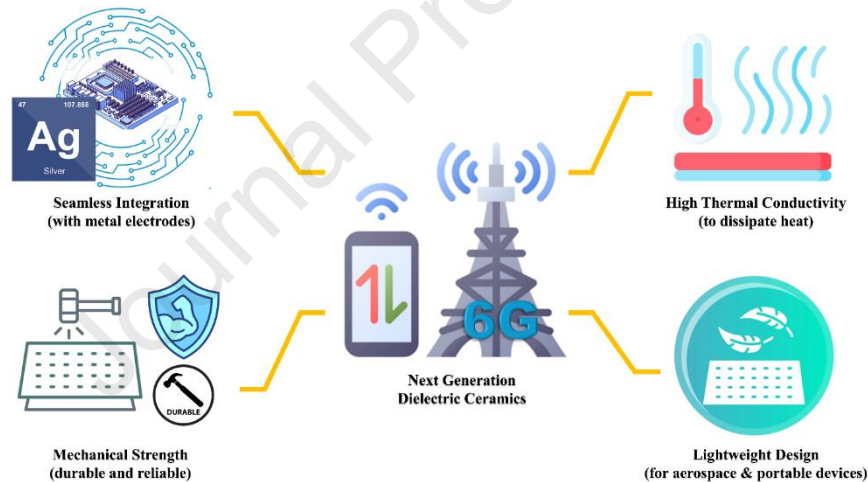
1378 **8.2.2 Ultra-Low and Cold Sintering: The Next Frontier**

1379 Ultra-low temperature co-fired ceramics (ULTCC, $T_s \sim 400$ °C–700 °C) and cold sintering
1380 processes (CSP, $T_s < 200$ °C) address fundamental limitations of conventional LTCC by enabling
1381 co-firing with aluminum electrodes (melting point 660 °C), eliminating silver migration issues,
1382 and dramatically reducing energy consumption [154, 162]. The ULTCC6G-EPac project
1383 specifically targets energy-efficient electronic packaging for 6G systems through the development
1384 of ULTCC materials with sintering temperatures below 550 °C while maintaining $\epsilon_r = 6$ -12,
1385 $Q \times f > 40,000$ GHz, and $|\tau_f| < 30$ ppm/°C [162, 212]. Recent molybdate-based ULTCC systems
1386 demonstrate exceptional promise for 5G/6G applications. $\text{Na}_5\text{Tm}_{0.91}\text{Y}_{0.03}\text{Yb}_{0.06}(\text{MoO}_4)_4$ ceramics
1387 sintered at 600 °C achieve $\epsilon_r = 7.82$, $Q \times f = 34,752$ GHz, and $\tau_f = -71.9$ ppm/°C, with low sintering
1388 temperatures enabled by the liquid-phase formation during processing [154]. LiGaW_2O_8 ceramics
1389 sinter at 870 °C with $\epsilon_r \sim 14.4$, $Q \times f \sim 33,500$ GHz, suitable for 5G antenna substrates. Li_2MoO_4 -
1390 based systems achieve full densification at 540 °C with silver and aluminum electrode
1391 compatibility, positioning them as prime candidates for next-generation multilayer devices [153,
1392 202, 213]. Cold sintering at temperatures below 200 °C represents the ultimate low-temperature
1393 paradigm, with successful demonstrations of C0G multilayer ceramic capacitors and microwave
1394 dielectric resonators fabricated at 120 °C–180 °C [212]. SrF_2 -based dielectric resonator antennas
1395 cold-sintered at 140 °C and post-annealed at 450 °C resonate at 24.5 GHz with outstanding S_{11}
1396 performance, proving the viability of cold sintering for millimeter-wave 5G applications [162,
1397 212]. Cold-sintered MgO-based composites (MgO-TiO_2 , $\text{MgO-Na}_2\text{MoO}_4$) achieve relative
1398 densities $> 95\%$ at 200 °C with subsequent post-annealing at 600–800 °C optimizing microwave
1399 properties to $Q \times f > 50,000$ GHz [180].

1400 **8.3 The Multifunctional Design Imperative for 6G and Beyond**

1401 The evolution toward 6G and beyond demands a paradigm shift in materials design, moving
 1402 beyond the historical focus on optimizing the dielectric triad (ϵ_r , $Q \times f$, τ_f) in isolation. Deployment
 1403 in practical systems, particularly aerospace platforms, high-power base stations, and portable
 1404 devices, requires a holistic, multifunctional design framework that concurrently addresses
 1405 competing requirements. As conceptually summarized in Fig. 18, next-generation dielectric
 1406 ceramics must simultaneously exhibit lightweight design, high thermal conductivity, robust
 1407 mechanical strength, and seamless integration with metal electrodes. This section delves into the
 1408 specific challenges and emerging material strategies for achieving this multifunctional
 1409 performance in low-temperature sinterable systems.

1410



1411

1412 **Fig. 18** A holistic design approach for next-generation microwave dielectric ceramics for 6G and
 1413 beyond. Future research must move beyond optimizing only dielectric properties and holistically
 1414 address key multifunctional requirements, including lightweight design for aerospace and
 1415 portable applications, high thermal conductivity for heat dissipation in high-power devices,
 1416 robust mechanical strength for durability, and seamless integration with metal electrodes for cost-
 1417 effective manufacturing.

1418 **8.3.1 Lightweight, high-performance ceramics for mm-wave/THz**

1419 The progression toward 6G sub-terahertz frequencies (100–300 GHz) demands ultra-low-loss
1420 materials ($\tan \delta < 10^{-5}$, $Q \times f > 200,000$ GHz) while simultaneously addressing weight constraints
1421 for aerospace-mounted 6G nodes and satellite constellations. Low-temperature sintered ceramics
1422 offer unique advantages: reduced grain growth during shorter thermal exposure preserves dense,
1423 defect-free microstructures that minimize scattering losses at terahertz frequencies [55].

1424 $\text{Na}_5\text{RE}(\text{MoO}_4)_4$ systems (RE=Y, Yb) sintered at 570 °C–600 °C exhibit $Q \times f$ values up to
1425 56800 GHz with densities below 4.5 g/cm³, positioning them as lightweight candidates for
1426 frequency-agile 6G antenna substrates requiring tunable ϵ_r ($\epsilon_r \sim 7-9$) for beam-steering
1427 applications. Magnesium-based low-temperature ceramics (MgO, Mg₃B₂O₆, MgTiO₃) achieve
1428 densities of 2.8–3.2 g/cm³—40% lighter than conventional alumina substrates, while maintaining
1429 $Q \times f > 60,000$ GHz at sintering temperatures below 900 °C with LiF or V₂O₅ fluxes [180, 202].

1430 **8.3.2 Co-Firing Compatibility and 3D Integration**

1431 Low-temperature regimes fundamentally enable seamless co-firing with low-cost silver and
1432 copper electrodes, eliminating the platinum/palladium requirements of high-temperature ceramics
1433 and reducing metallization costs by 60%–80%. ULTCC systems co-fired at 500 °C–650 °C with
1434 silver demonstrate no interfacial reactions or Ag diffusion beyond 5 μm depths, maintaining
1435 stable electrical contact and preventing secondary phase formation that degrades dielectric
1436 properties [214].

1437 Three-dimensional integration via LTCC/ULTCC enables vertical stacking of antenna arrays,
1438 filters, power dividers, and passives within compact multilayer modules, critical for space-
1439 constrained 5G small cells and 6G reconfigurable intelligent surfaces (RIS). Ten-layer LTCC
1440 modules with embedded cavities, vias, and microstrip circuits achieve component densities

1441 exceeding 200 elements/cm³ while maintaining inter-layer registration tolerances below 15 μm
1442 through co-sintering at 850 °C–900 °C [210].

1443 Cold sintering uniquely permits hybrid ceramic–polymer composites and ceramic-metal
1444 cermets by avoiding thermal degradation of organic phases, enabling multifunctional structures
1445 combining electromagnetic performance with mechanical damping, thermal spreading, or
1446 embedded sensing capabilities [162, 212].

1447 **8.4 AI-Accelerated Discovery of Low-Temperature Dielectric Ceramics**

1448 The vast compositional space of low-temperature sinterable systems, spanning molybdates,
1449 tungstates, vanadates, fluorides, borates, and their composites, exceeds manual exploration
1450 capacity. Machine learning-guided materials design trained on existing LTCC/ULTCC databases
1451 can predict sintering temperatures, ϵ_r , $Q \times f$, and τ_f from composition and structure descriptors,
1452 accelerating identification of novel low-temperature ceramics meeting 6G specifications [215].

1453 High-entropy ceramic (HEC) strategies applied to low-temperature regimes offer
1454 simultaneous optimization of multiple properties through configurational disorders. Rare-earth-
1455 doped molybdate HECs (*e.g.*, Na₅(Tm, Y, Yb)(MoO₄)₄) demonstrate that multi-element
1456 substitution tunes τ_f from –101 to –71.9 ppm/°C while lowering sintering temperatures and
1457 improving $Q \times f$, suggesting a rich design space for AI exploration [202, 216].

1458 Autonomous robotic synthesis platforms integrating low-temperature solid-state reactions
1459 ($T < 800$ °C), in-situ phase analysis, and microwave resonator testing could screen 50–100
1460 ULTCC/CSP compositions per week, two orders of magnitude faster than conventional research
1461 workflows. Digital twin frameworks for LTCC manufacturing enable real-time prediction of
1462 sintering shrinkage, warpage, and electrical performance, reducing prototype iterations and time-
1463 to-market for 6G components by 40%–60% [217]. The key scientific challenges, advanced

1464 solutions, and targeted applications for each low-temperature sintering strategy are systematically
 1465 summarized in Table 9. Below, we elaborate on several high-priority directions that will shape
 1466 the next decade of research.

1467 **8.5 Vision: low-temperature ceramics as enablers of sustainable 6G**

1468 The future trajectory of microwave dielectric ceramics for 6G is not a simple extrapolation
 1469 of past achievements; it demands a paradigm shift towards a holistic integration of low-
 1470 temperature processing, multifunctional performance, and sustainable manufacturing. The era of
 1471 optimizing dielectric properties in isolation is over. To successfully enable next-generation
 1472 technologies, we must concurrently address the competing demands of electrical performance,
 1473 thermal management, mechanical robustness, and seamless co-integration.

1474 To synthesize the complex landscape discussed throughout this review and provide a clear
 1475 path forward, Table 9 presents a strategic roadmap for the field.

1476
 1477 **Table 9** A Strategic Roadmap for Low-Temperature Microwave Dielectric Ceramics: Challenges,
 1478 Opportunities, and Future Directions.

Sintering strategy	Key scientific/technical challenges	Key opportunities & advanced solutions	Future directions & target applications (6G and beyond)
Sintering aids / glass additives	- Residual amorphous phase limiting $Q \times f$ - Secondary phase formation - Precise composition control	- Glass-ceramic design: Develop crystallizable glasses that become part of the functional phase. - Multi-component glass engineering (via CALPHAD/ML): Predict optimal glass compositions to	- Cost-effective LTCC for massive MIMO antenna arrays (Sub-6 GHz & low mm-Wave). - High-volume substrate manufacturing.

		minimize reactions and melting point.	
		- Nanoscale Coating: Apply sintering aids as thin, uniform coatings instead of mixed powders.	
Intrinsically Low-T Compounds	<ul style="list-style-type: none"> - Li/Na volatilization during sintering - Limited material families discovered - Fine-tuning τ_f to near-zero can be difficult 	<ul style="list-style-type: none"> - High-Entropy Design: Stabilize crystal structures and tune properties by introducing configurational disorder. - Anion Substitution (F⁻, N³⁻): Weaken lattice bonds to further reduce sintering temperature. - AI-Accelerated Discovery: Screen new, stable low-energy compounds (e.g., novel tellurates, vanadates). 	<ul style="list-style-type: none"> - High-performance ULTCC for mm-Wave/Sub-THz filters and resonators ($Q \times f > 100000$ GHz). - Lightweight ceramics for aerospace and satellite communications.
Cold Sintering Process (CSP)	<ul style="list-style-type: none"> - Residual Hydroxyls (OH⁻): The primary source of dielectric loss, severely limiting $Q \times f$. - Amorphous/ defective grain boundaries - Limited material solubility in common solvents. 	<ul style="list-style-type: none"> - Hybrid Processing (Post-Annealing): Use CSP for shaping, followed by a moderate-temperature anneal (400 °C-800 °C) to remove OH⁻ and crystallize boundaries. - Advanced Solvent Engineering: Explore non-aqueous or chemically reactive transient liquids to promote congruent dissolution. 	<ul style="list-style-type: none"> - Co-integration with Polymers/Metals: Fabricate 3D heterogeneous packages with embedded components (e.g., Al electrodes). - Flexible/wearable electronics. - Sustainable manufacturing for next-gen green electronics.

- Microwave/Field-Assisted

CSP: Enhance kinetics at the
particle-liquid interface.

1479

1480 It systematically outlines the persistent scientific challenges, key technological opportunities,
1481 and targeted future applications for each of the three primary low-temperature sintering strategies.
1482 This roadmap crystallizes the critical research frontiers that must be conquered to unlock the full
1483 potential of these materials.

1484 Building upon this strategic foundation, the vision for the next decade of research and
1485 development can be distilled into several concrete, ambitious goals. These goals represent the
1486 collective mission to transform low-temperature microwave ceramics from mere passive
1487 components into foundational enablers of an energy-efficient, cost-effective, and environmentally
1488 sustainable 6G communication infrastructure. The key milestones for this vision include:

- 1489 • Sub-600°C sintering for all major device classes (resonators, filters, antennas, capacitors)
1490 to enable aluminum electrode co-firing and 50% energy reduction [180, 216].
- 1491 • Ultra-low loss at mm-wave/THz ($Q \times f > 100,000$ GHz, $\tan \delta < 10^{-4}$) through crystalline,
1492 low-porosity microstructures achievable via cold sintering + controlled post-annealing
1493 [202, 213].
- 1494 • Lightweight architectures ($\rho < 3.5$ g/cm³) using magnesium-, sodium-, and lithium-based
1495 chemistries compatible with aerospace 6G nodes [158, 210].
- 1496 • Thermal conductivity enhancement ($\lambda > 10$ W·m⁻¹·K⁻¹) via low-temperature-compatible
1497 nitride/carbide fillers for high-power massive MIMO [180, 218].
- 1498 • 3D heterogeneous integration of ceramics, semiconductors, and passives through
1499 LTCC/ULTCC co-sintering below 700 °C [214].

1500 This paradigm shift positions low-temperature microwave ceramics not merely as passive
1501 components but as transformative enablers of energy-efficient, cost-effective, and
1502 environmentally sustainable 6G communication infrastructure capable of supporting terabit-per-
1503 second data rates, ubiquitous connectivity, and global digital equity.

1504 **9. Conclusions**

1505 The development of high-performance microwave dielectric ceramics requires both
1506 excellent intrinsic properties and low-temperature densification. Traditional high-temperature
1507 sintering is energy-intensive and causes stoichiometric variations, while also requiring additional
1508 processing steps for metal electrode integration. Three main strategies have been developed to
1509 lower sintering temperatures. The use of sintering aids, especially multi-component glasses such
1510 as borosilicate-based systems, offers a cost-effective route, but careful glass selection is crucial to
1511 avoid secondary phases and degraded $Q \times f$. Alternatively, intrinsically low-sintering-temperature
1512 compounds, particularly Li-based rock-salt, spinel, and olivine systems, achieve excellent
1513 microwave properties at 850–950 °C through fast Li^+ diffusion and weak Li–O bonds. Partial
1514 anion substitution (*e.g.*, O^{2-} by F^-) further reduces processing temperatures without sacrificing
1515 performance. CSP represents a paradigm shift, enabling densification at ultra-low temperatures
1516 (<300 °C) via a dissolution-precipitation mechanism. While molybdate-based systems densify
1517 successfully with deionized water, molybdenum cost drives the search for alternative affordable
1518 materials such as aluminates, titanates, and phosphates. Understanding the interplay between
1519 CSP processing parameters (solvent, pressure, temperature, time) and microstructure (grain size,
1520 residual OH^- , amorphous phases) is essential for tailoring properties.

1521 In summary, sintering aids, intrinsically low- T_s materials, and CSP each offer distinct
1522 advantages and limitations. The optimal choice depends on the specific frequency band, co-firing

1523 requirements, and manufacturing constraints. This review provides a critical, comparative
 1524 framework to guide future material selection and processing design, as further elaborated in the
 1525 strategic roadmap (Table 9).

1526 10. References

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